

AMIGA AUCKLAND INC.
PO BOX 24-467
ROYAL OAK 1030
AUCKLAND, NEW ZEALAND

A500 SERVICE TRAINING

Venue Commodore Business Machines
Unit 13/1, 663 Victoria Street
Abbotsford, VIC 3067

AMIGA AUCKLAND INC.
PO BOX 24-467
ROYAL OAK 1030
AUCKLAND, NEW ZEALAND

Date 19 SEP 1989

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(Technical Support Manager)

COURSE OUTLINE

This training course is designed to help service technicians better understand the hardware and component level repair of the A500 Computer. It assumes a basic computer and electronic knowledge as well as the basic operation of the computer.

A500 Technical specifications

Power supply specifications

68000 Microprocessor

- Basic Architecture
- Interface signals
- Data organization in memory

Custom Chips, Features and functional block diagrams

- Paula
- Denise
- Fat Agnus
- Gary

Theory of operations

- System clock sub-system
- ROM sub-system
- Keyboard
- Keyboard interface

Theory of operations cont'

- Mouse interface
- Display interface
- Floppy disk drive
- Floppy drive interface
- Audio sub-system
- Printer interface
- RS232 interface
- Real Time Clock interface
- RAM sub-system
- Expansion RAM sub-system

System Block Diagram

RAM Access

- 68000 chip Ram access
- Agnes chip Ram access

System Memory Map

Common troubleshooting approaches

- Software
- Hardware
- Others

Common Faults

Power up self-test

- Power up self-test
- Keyboard power up self-test

Diagnostics

- System Diagnostic
- Rom based diagnostic

Waveform Comparison

DRAM Refresh waveform

Chip/Expansion Ram swaps

NO-OPT 68000

Disk drive alignment

A500 POWER SUPPLY SPECIFICATIONS

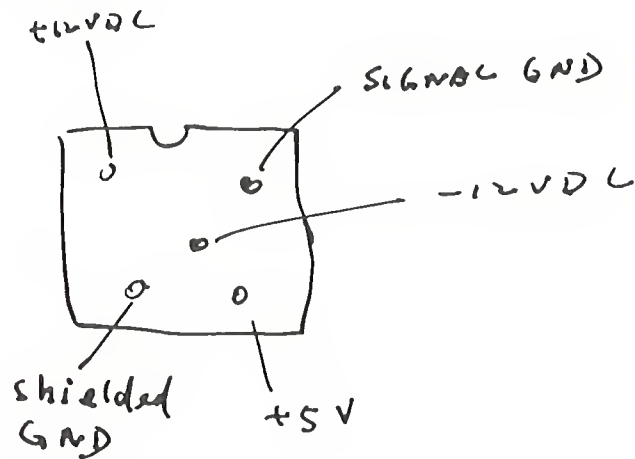
AC INPUT 216-264 VAC

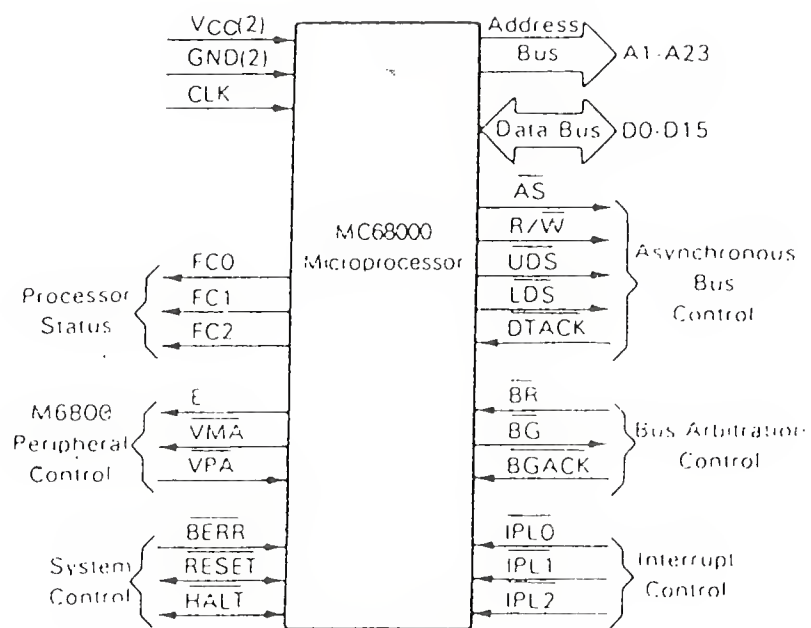
AC FREQ 47-53 Hz

DC OUTPUT	5V	4.5A max
	12V	1.0A max
	-12V	0.1A max

MAX POWER 35 WATTS

CONNECTOR PIN OUT





68000 SIGNAL DESCRIPTION

A1 - A23 : ADDRESS BUS
23 BIT ADDRESS 16M BYTE
DURING INTERRUPT A1 - A3 INDICATE LEVEL OF INT

DO - D15 : 16 BIT DATA BUS, TRANSFER DATA IN BYTE OR WORD

AS ADDRESS STROBE : VALID ADDRESS ON ADDRESS BUS

UDS UPPER DATA STROBE
LDS LOWER DATA STROBE

UDS	LDS	D8 - D15	DO - D7
0	1	VALID	NOT VALID
1	0	NOT VALID	VALID
0	0	VALID	VALID

D TACK DATA TRANSFER ACKNOWLEDGE
DEVICE → CPU

BR BUS REQUEST	DEVICE → CPU	↕
BG BUS GRANT	CPU → DEVICE	
B GACK BUS GRANT ACK.	DEVICE → CPU	

IPLO, IPL1, IPL2 INTERRUPT CONTROL
7 LEVEL OF INTERRUPT

BERR BUS ERROR DEVICE → CPU

RESET RESET, BI-DIRECTIONAL
TOTAL SYSTEM RESET REQUIRES HALT & RESET

HALT DEVICE → CPU, BUSES & CONTROL → TRI STATE

DATA REGISTERS DO - D7
CAN BE USED FOR BYTE, WORD, LONG WORD DATA OPERATIONS

ADDRESS REGISTERS A0 - A7

USED FOR:

- BASE ADDRESS REGISTERS
- WORD ADDRESS
- LONG WORD ADDRESS
- INDEX REGISTER

STACK POINTER A7
 { A7 USER STACK POINTER
 { A7' SUPERVISOR STACK POINTER

SWAIT



S0 S1 S2 S3 S4 S5 S6 S7

$7MHz \Rightarrow$

$S_0 + S_1 = 280ns$

$8 \times 140 = 1120ns$

A1-A23

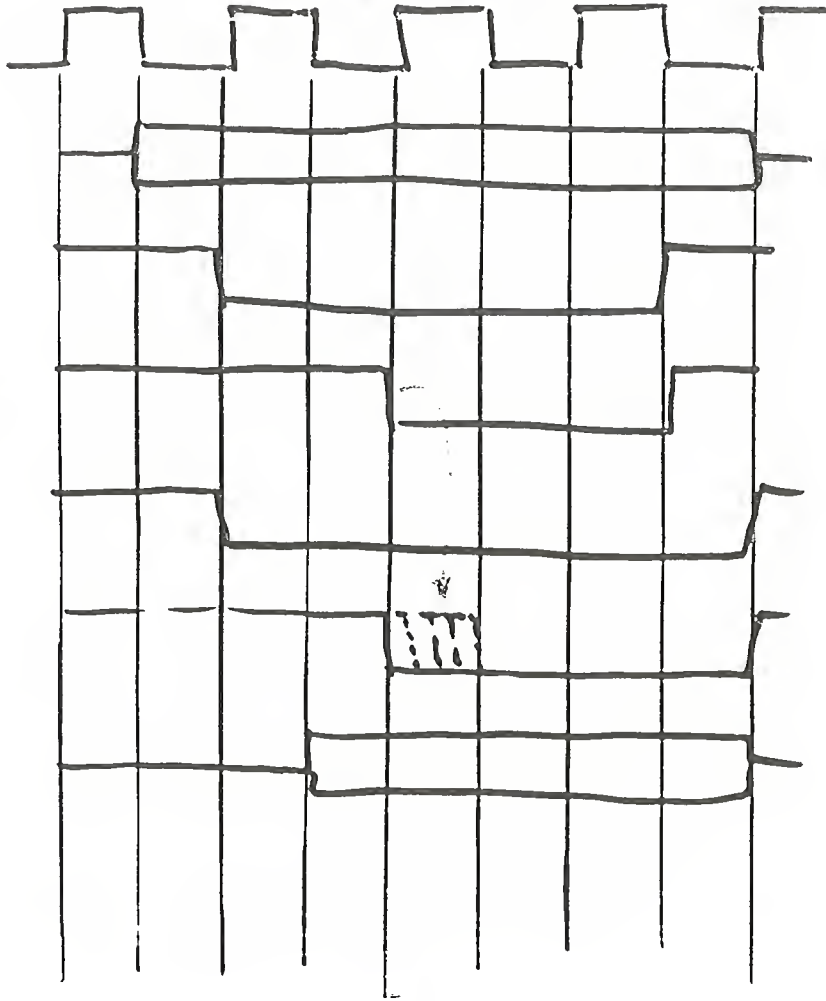
\overline{AS}

$\overline{UDS}, \overline{LDS}$

R/\overline{W}

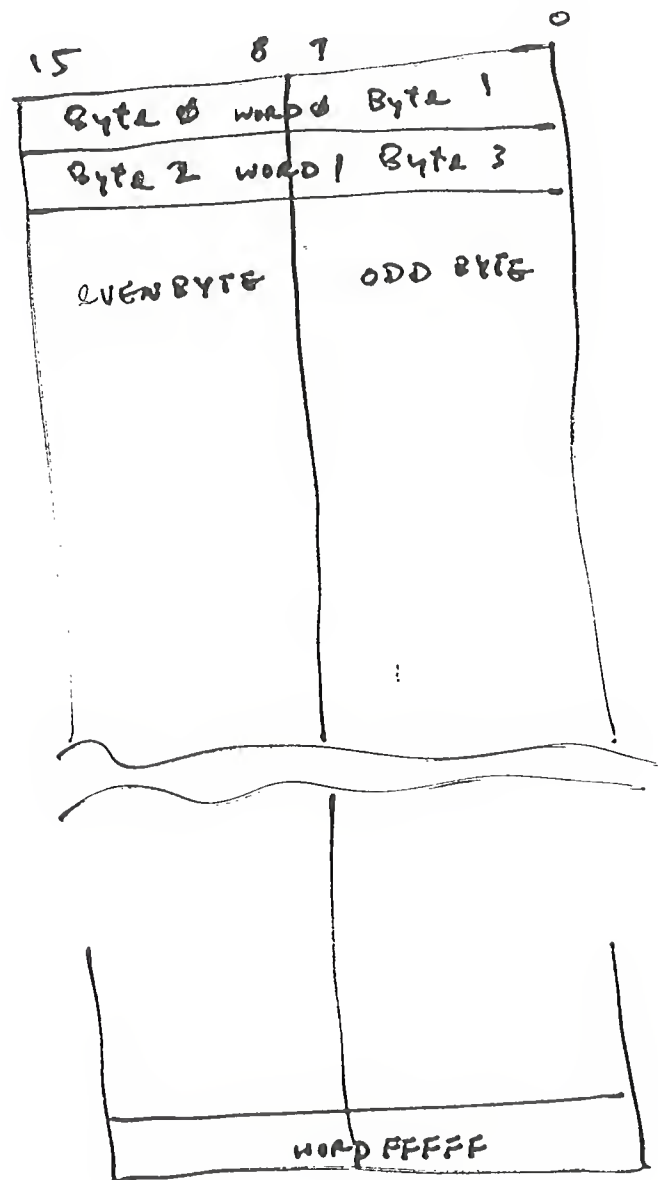
\overline{DTACK}

DATA



68000 WRITE TIMING

DATA ORGANIZATION IN MEMORY FOR 68000 SYSTEM



D8	<input type="checkbox"/>	1	18	<input type="checkbox"/>	D9
D7	<input type="checkbox"/>	2	47	<input type="checkbox"/>	D10
D6	<input type="checkbox"/>	3	46	<input type="checkbox"/>	D11
D5	<input type="checkbox"/>	4	45	<input type="checkbox"/>	D12
D4	<input type="checkbox"/>	5	44	<input type="checkbox"/>	D13
D3	<input type="checkbox"/>	6	43	<input type="checkbox"/>	D14
D2	<input type="checkbox"/>	7	42	<input type="checkbox"/>	D15
VSS	<input type="checkbox"/>	8	41	<input type="checkbox"/>	RXD
D1	<input type="checkbox"/>	9	40	<input type="checkbox"/>	TXD
D0	<input type="checkbox"/>	10	39	<input type="checkbox"/>	DKWB
RES	<input type="checkbox"/>	11	38	<input type="checkbox"/>	DKWD
DHAL	<input type="checkbox"/>	12	37	<input type="checkbox"/>	DKRD
IPL0	<input type="checkbox"/>	13	36	<input type="checkbox"/>	PIY
IPL1	<input type="checkbox"/>	14	35	<input type="checkbox"/>	PIX
IPL2	<input type="checkbox"/>	15	34	<input type="checkbox"/>	ANAGND
INT2	<input type="checkbox"/>	16	33	<input type="checkbox"/>	P0Y
INT3	<input type="checkbox"/>	17	32	<input type="checkbox"/>	P0X
INT6	<input type="checkbox"/>	18	31	<input type="checkbox"/>	AUDA
RGA8	<input type="checkbox"/>	19	30	<input type="checkbox"/>	AUDB
RGA7	<input type="checkbox"/>	20	29	<input type="checkbox"/>	CLKQ
RGA6	<input type="checkbox"/>	21	28	<input type="checkbox"/>	CLK
RGA5	<input type="checkbox"/>	22	27	<input type="checkbox"/>	VCC
RGA4	<input type="checkbox"/>	23	26	<input type="checkbox"/>	RGA1
RGA3	<input type="checkbox"/>	24	25	<input type="checkbox"/>	RGA2

5000

PAULA 8364

PORTS, AUDIO, UART, CHIP

37 REGISTERS

MAIN FEATURES

4 AUDIO CHANNELS. GENERATE COMPLEX
AM OR FM WAVEFORM

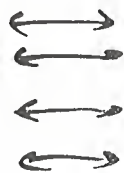
SERIAL PORT UART

DISK I/O PORT

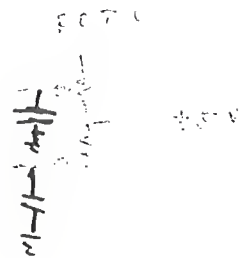
POT I/O PORT (PROPORTIONAL CONTROLLER)

INTERRUPT CONTROL , 6 LEVEL

PAULA BLOCK DIAGRAM



POT 0 X Y
POT 1 X Y



← IN

→ OUT



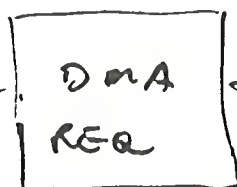
← IN

→ OUT



⇒ LEFT

⇒ RIGHT



→ TO AGNUS



⇒ TO 68000 INT.

← EXTERNAL &
AGNUS INTERRUPT

A stylized handwritten signature or mark.

AUDIO BLOCK - 4 CHANNELS
 - EACH CHANNEL HAS ITS DMA, DATA,
 FREQ, VOL REGISTERS
 - D TUA CONVERTER

DISK BLOCK - 3 REGISTERS: READ, WRITE, CONTROL
 - DATA PRE COMPENSATION FOR O/P
 - DATA SEP AND PLL FOR I/P

SERIAL BLOCK - REG_s, DATA
 CONTROL
 TRANSMIT
 RECEIVE

POT BLOCK - COUNTER CONVER CAP CHARGING
 TIME TO DATA

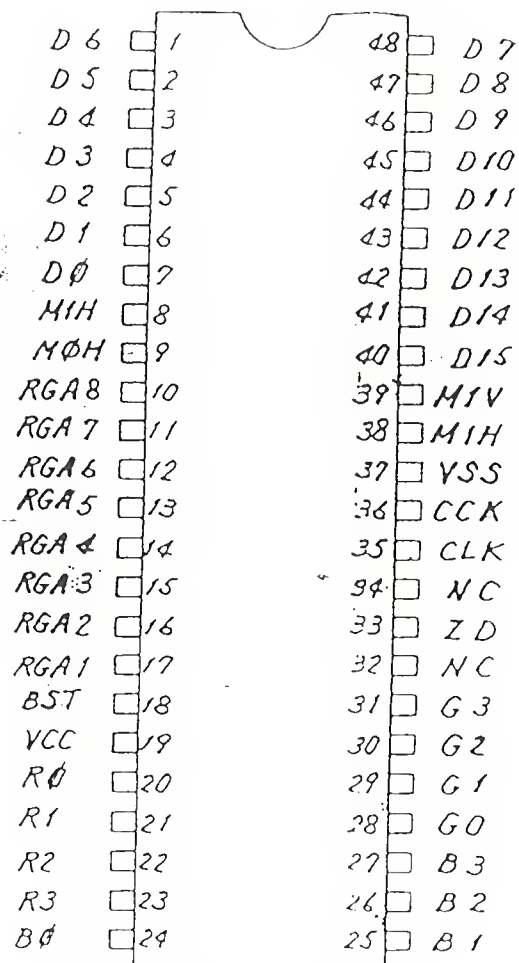
AUDIO AND DISK CONTROLLER USES DMA

DENISE 8362

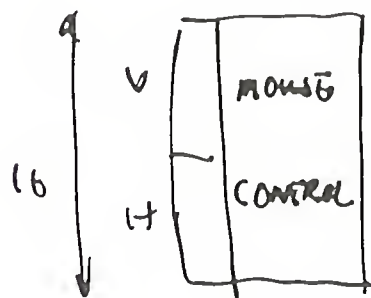
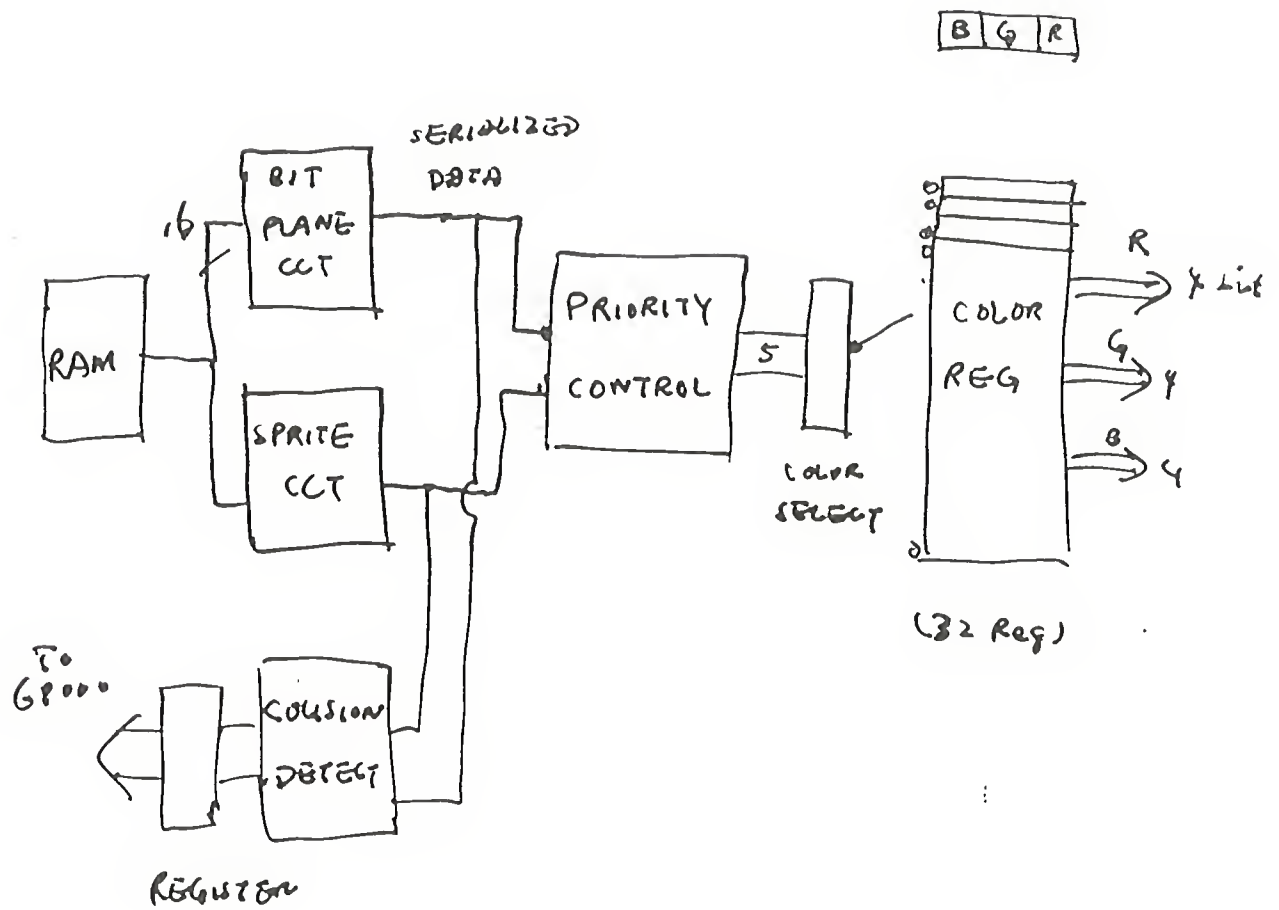
DISPLAY ENCODER

- 83 REGISTERS
- MAIN FEATURES
- SELECT OBJECT FOR DISPLAY
- ENCODE OBJECT TO RED, BLUE AND GREEN COLOR CODE
- RESOLUTION 320 X 200 TO 640 X 400
- 4096 COLORS
- SPRITE CONTROLLER

- DISPLAY BOTH BIT PLANE IMAGE AND SPRITE
- MOUSE INTERFACE



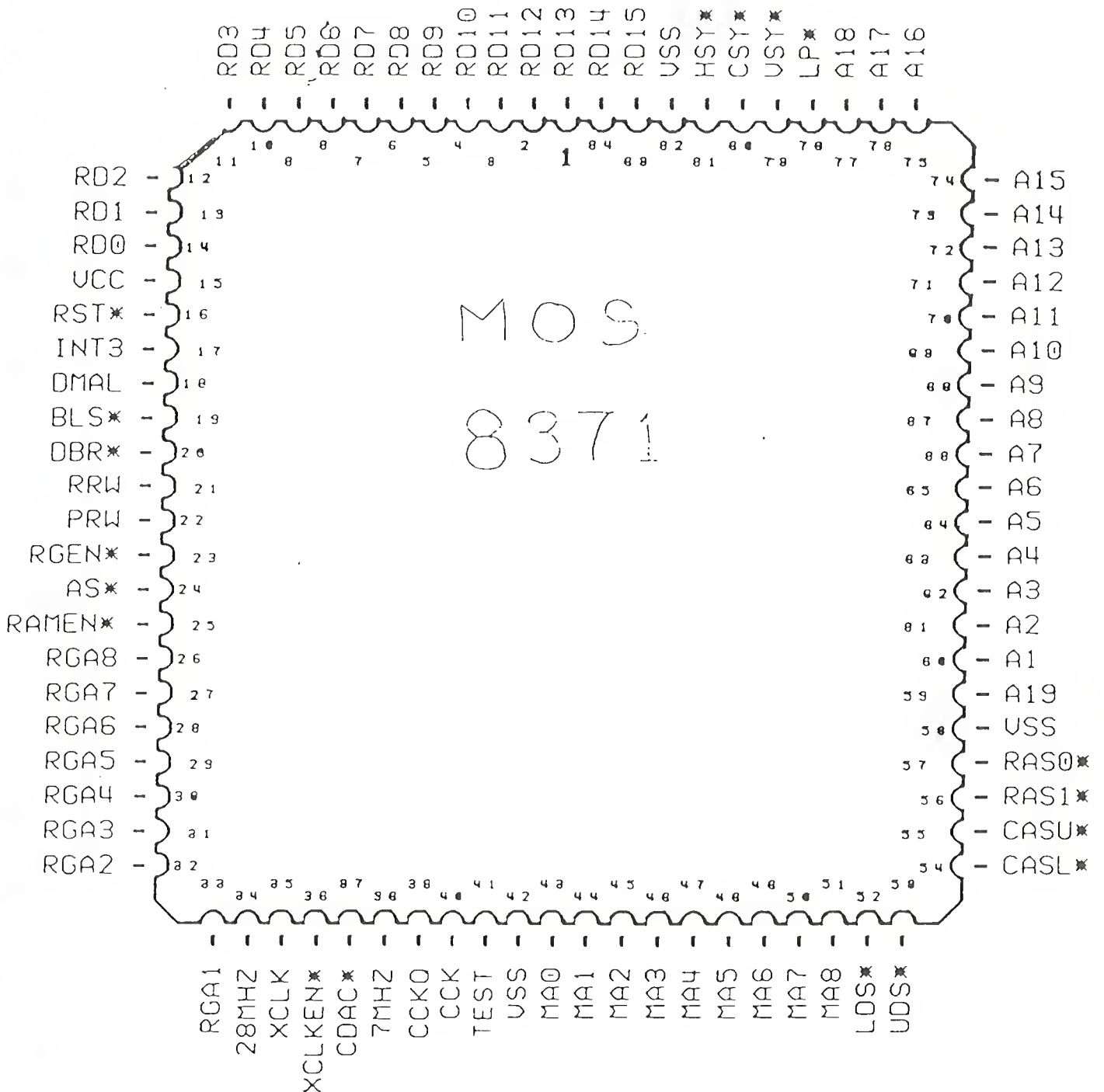
DENISE



DENISE BLOCK DIAGRAM

Custom Animation Chip

Fat Agnus



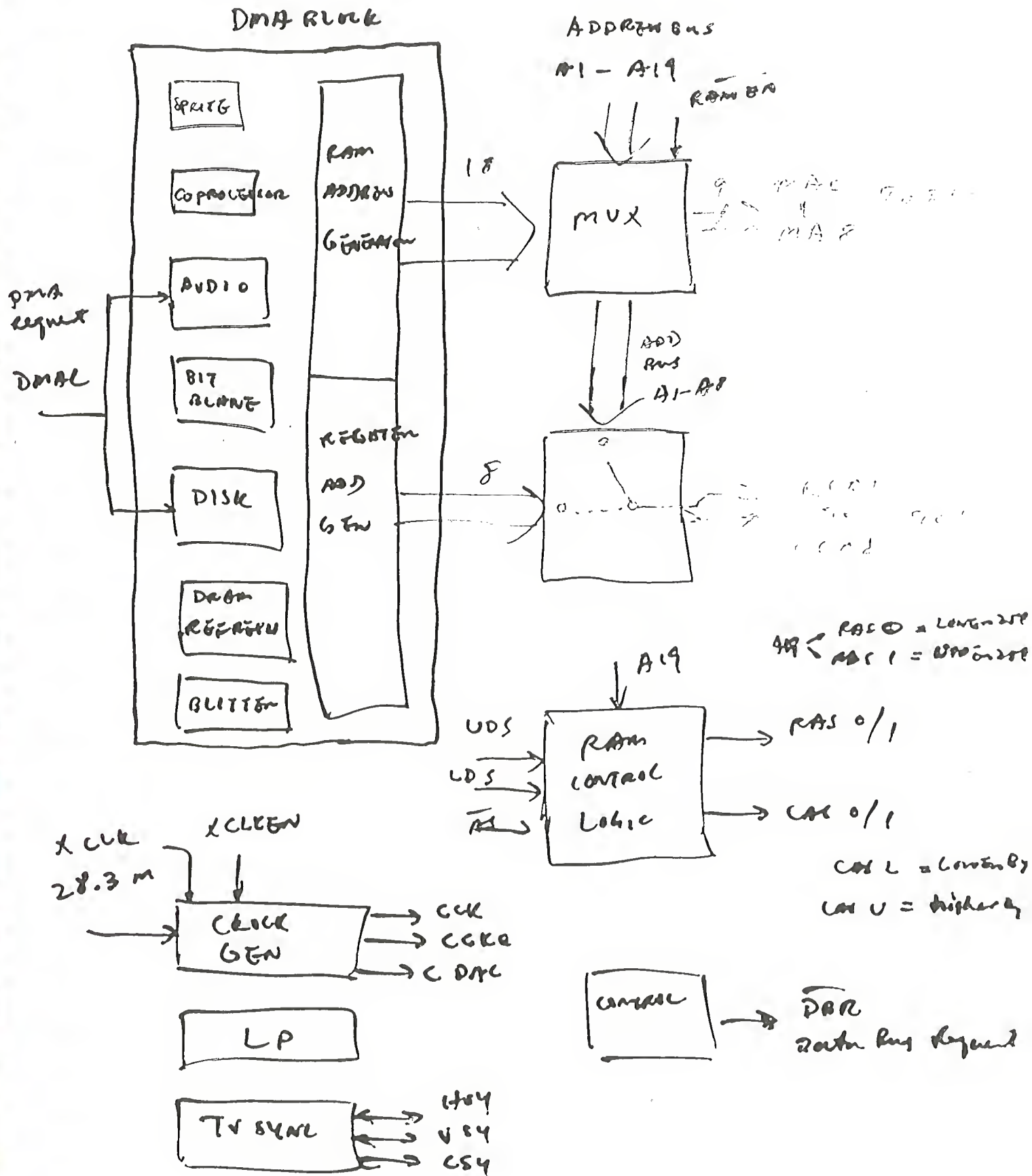
FAT AGNUS

ADDRESSS GENERATOR CHIP

MAIN FEATURES

- BITBLITTER ; MOVE DISPLAY DATA TO ALLOW HIGH SPEED ANIMATION
- CO - PROCESSOR ; CAN CONTROL 3 CUSTOM CHIPS DIRECTLY W.R.T. VIDEO BEAM
- CONTROL 25 DMA CHANNELS
- CLOCK CIRCUITRY
- RAM CONTROL SIGNALS (BOTH VIDEO AND EXP.)
- DRAM MULTIPLEXING ()
- 103 REGISTERS

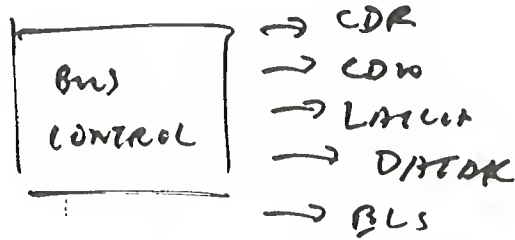
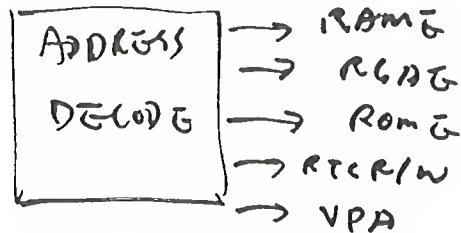
AGNES BLOCK DIAGRAM



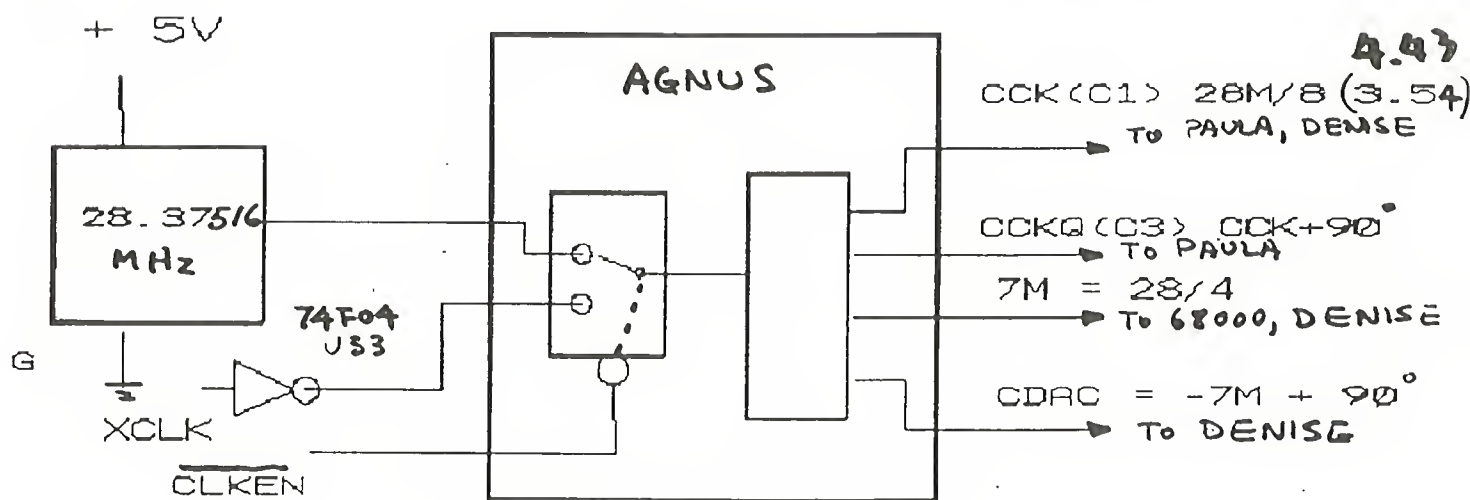
GARY

MAIN FEATURES

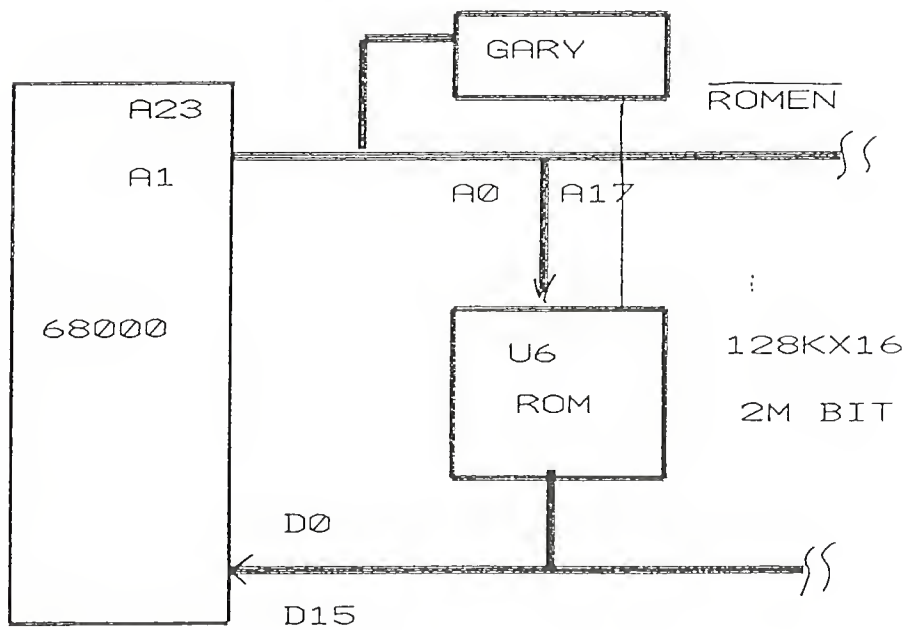
- PROVIDE ALL BUS CONTROL SIGNAL
- PROVIDE ALL ADDRESS DECODING
- HANDLES SOME FLOPPY CIRCUIT
- KEYBOARD RESET INTERFACE

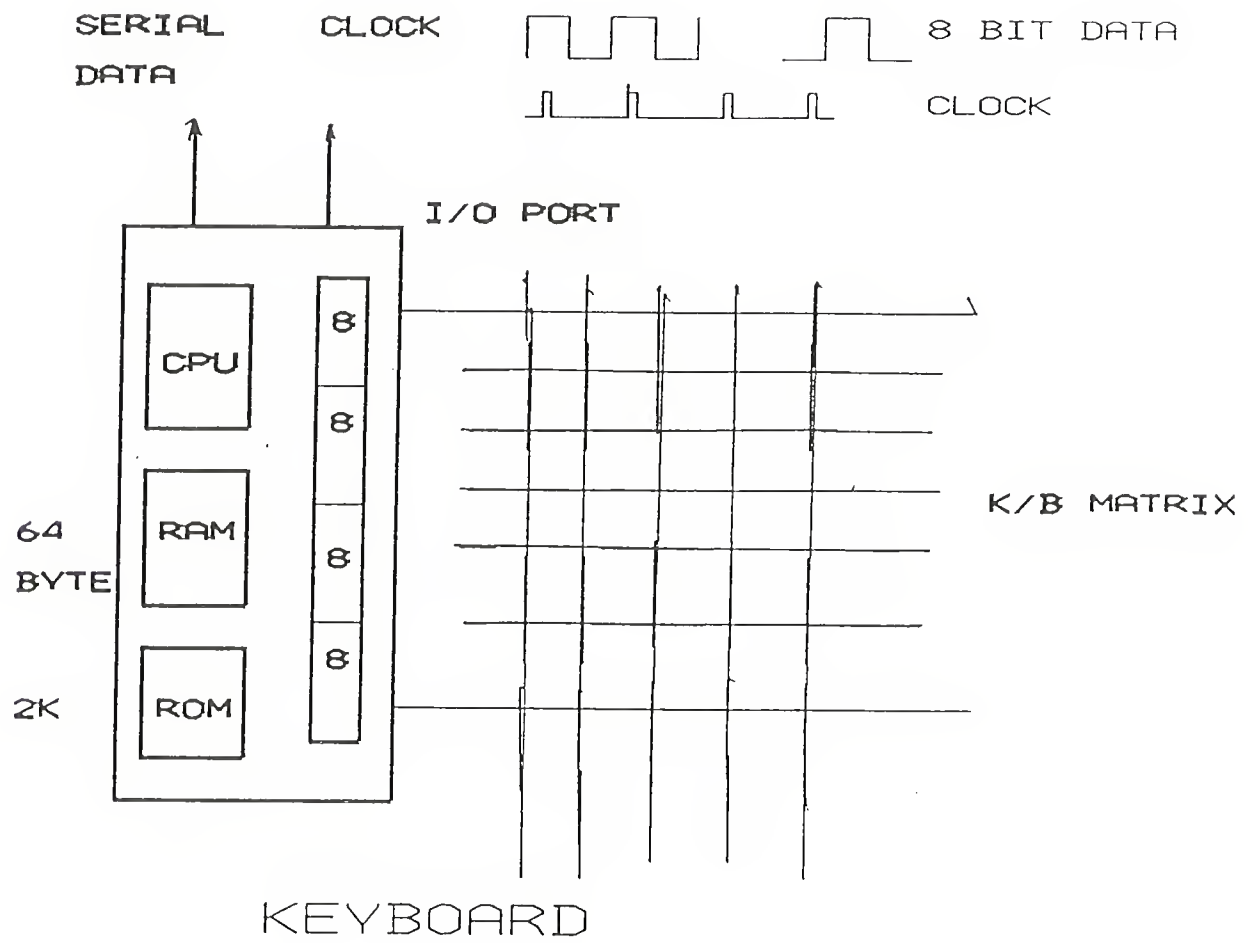


CLOCK CIRCUITRY

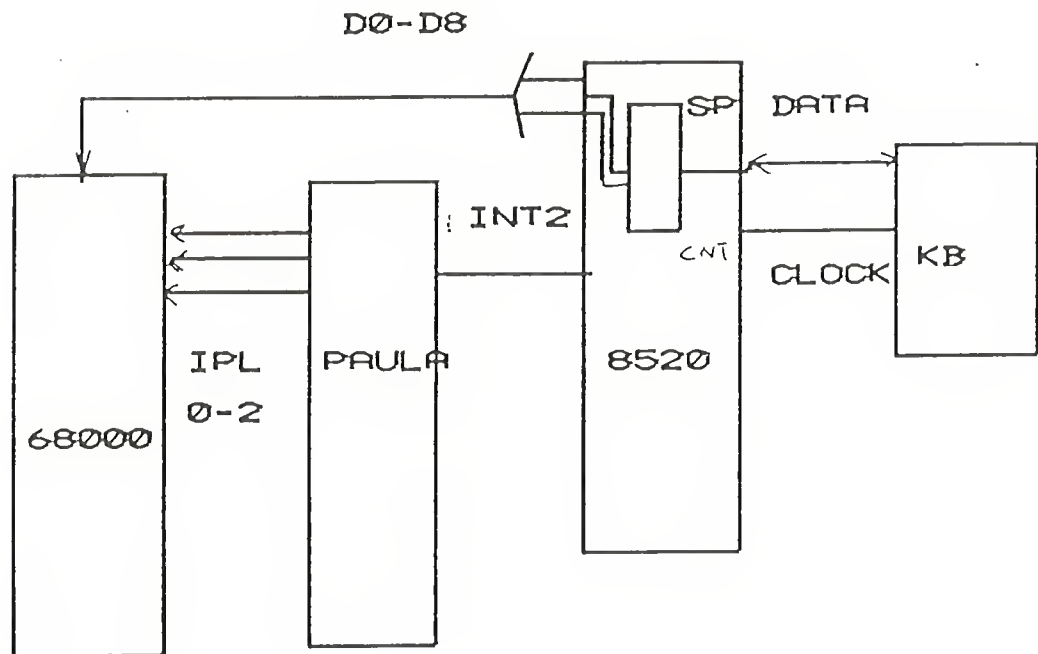


ROM SUB-SYSTEM



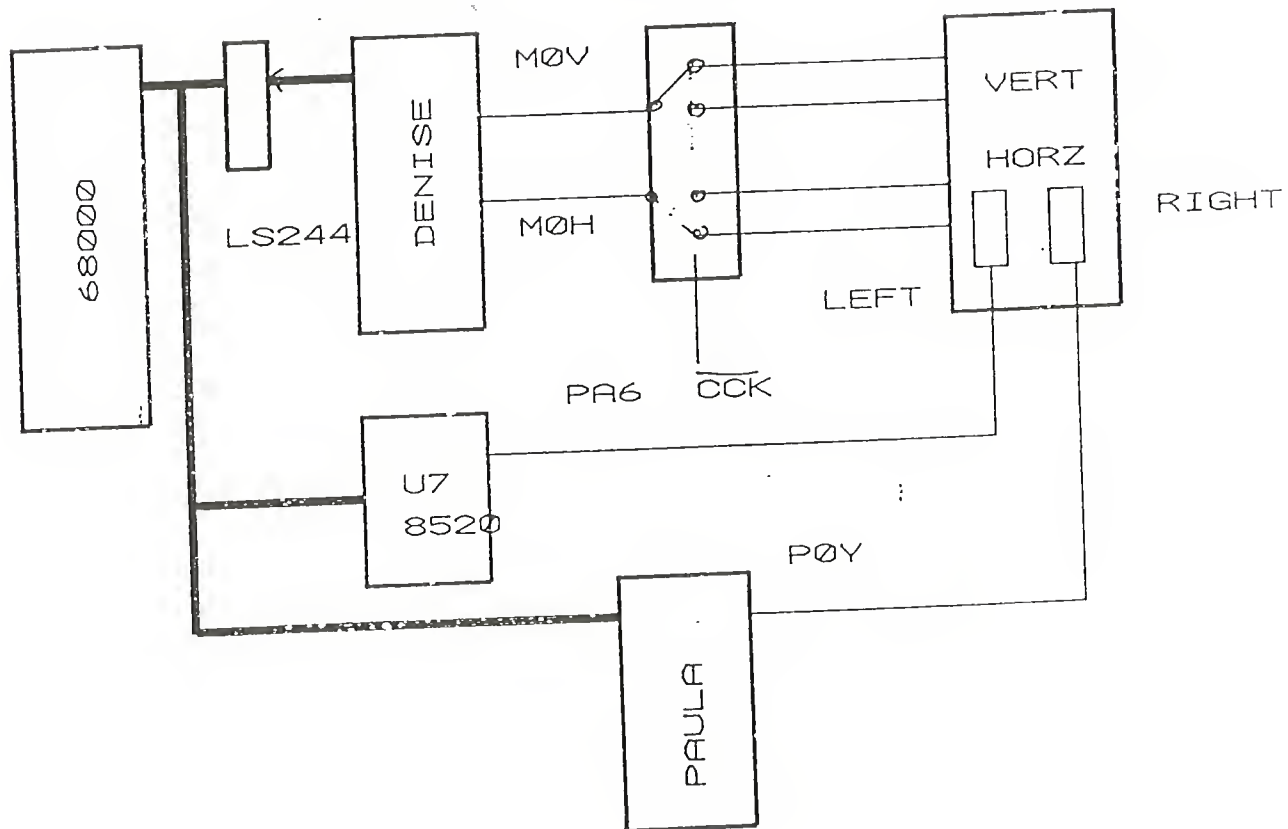


KEYBOARDDD INTERFACE

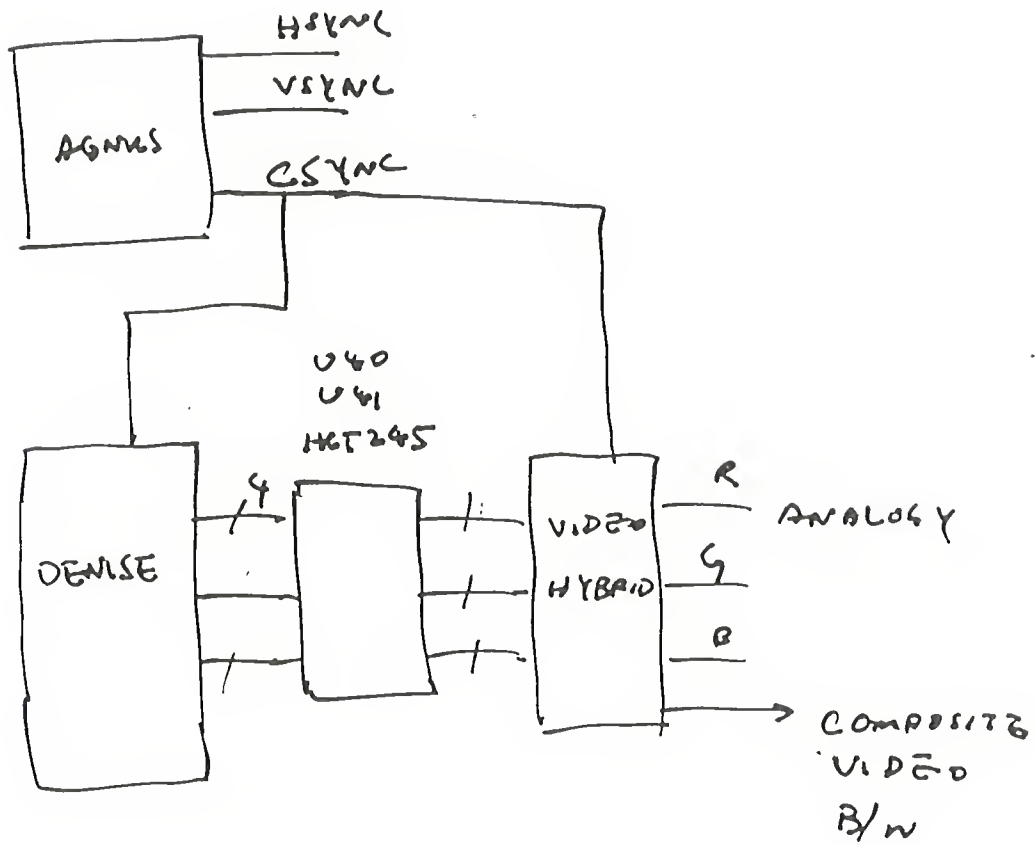


MOUSE INTERFACE

MOUSE
PORT 0

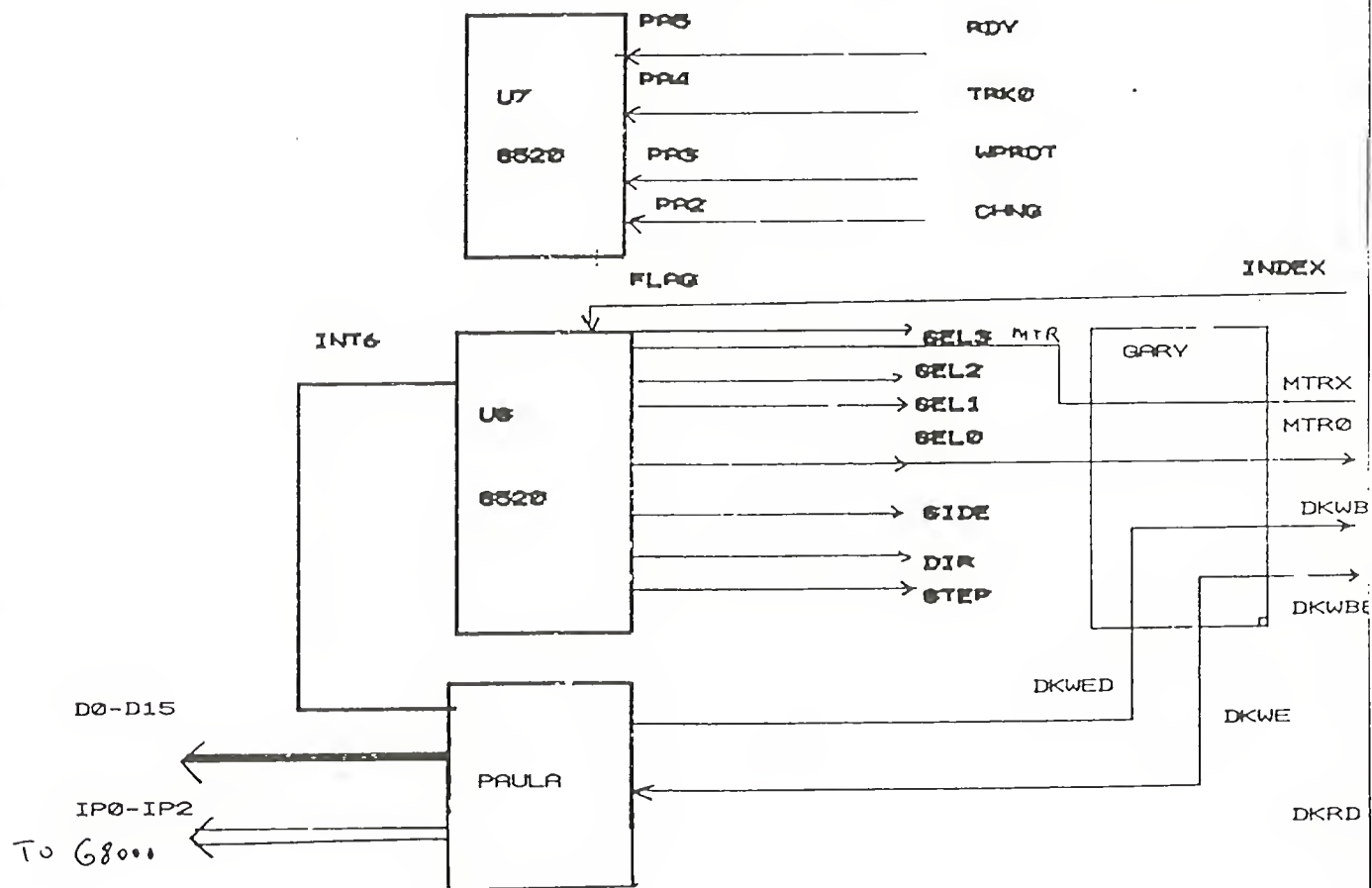


VIDEO INTERFACE

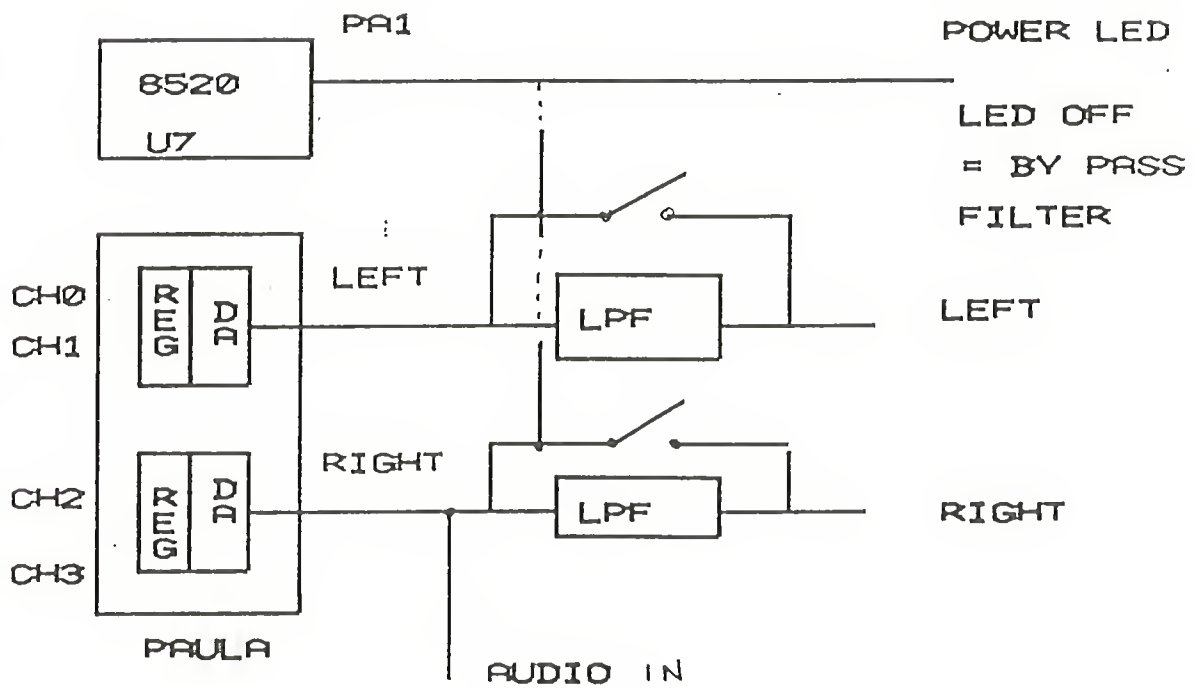


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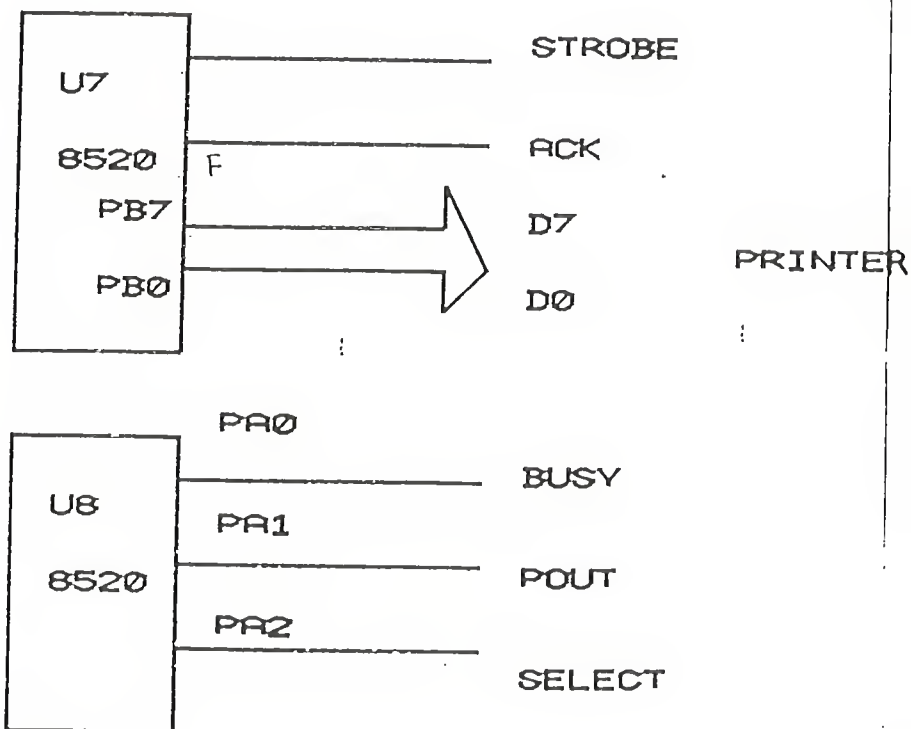
FLOPPY DRIVE INTERFACE



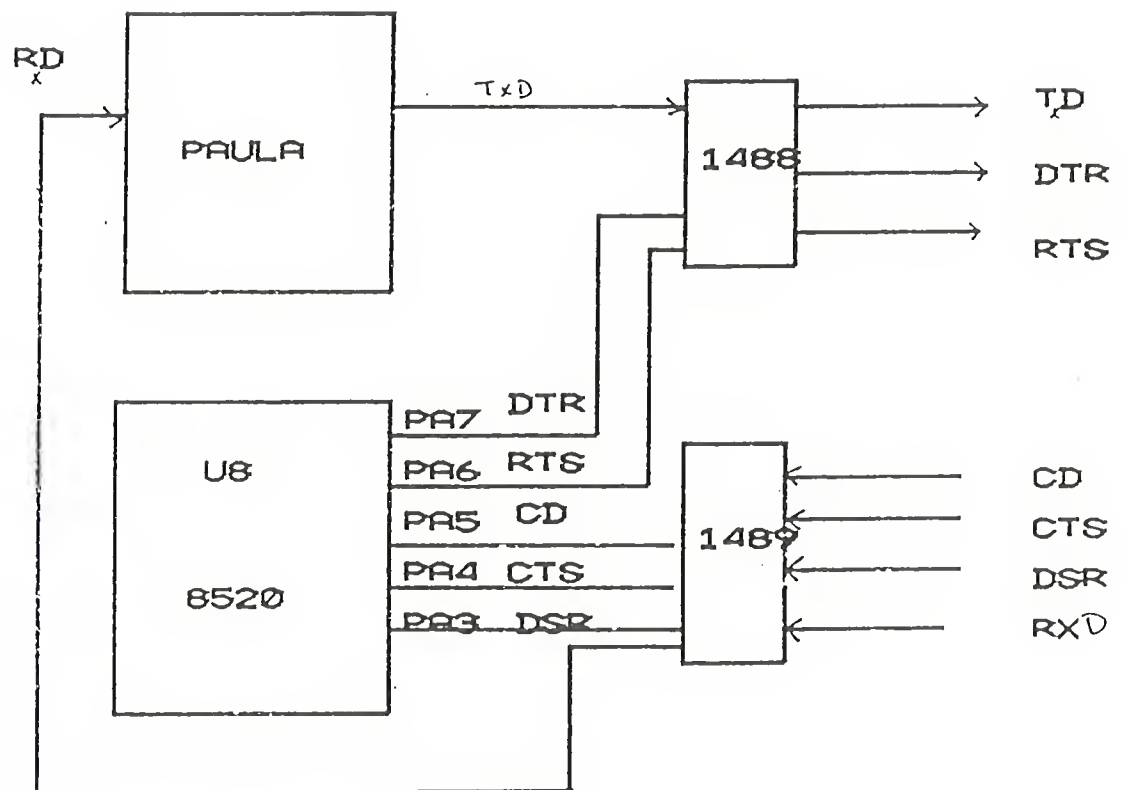
AUDIO SUB-SYSTEM



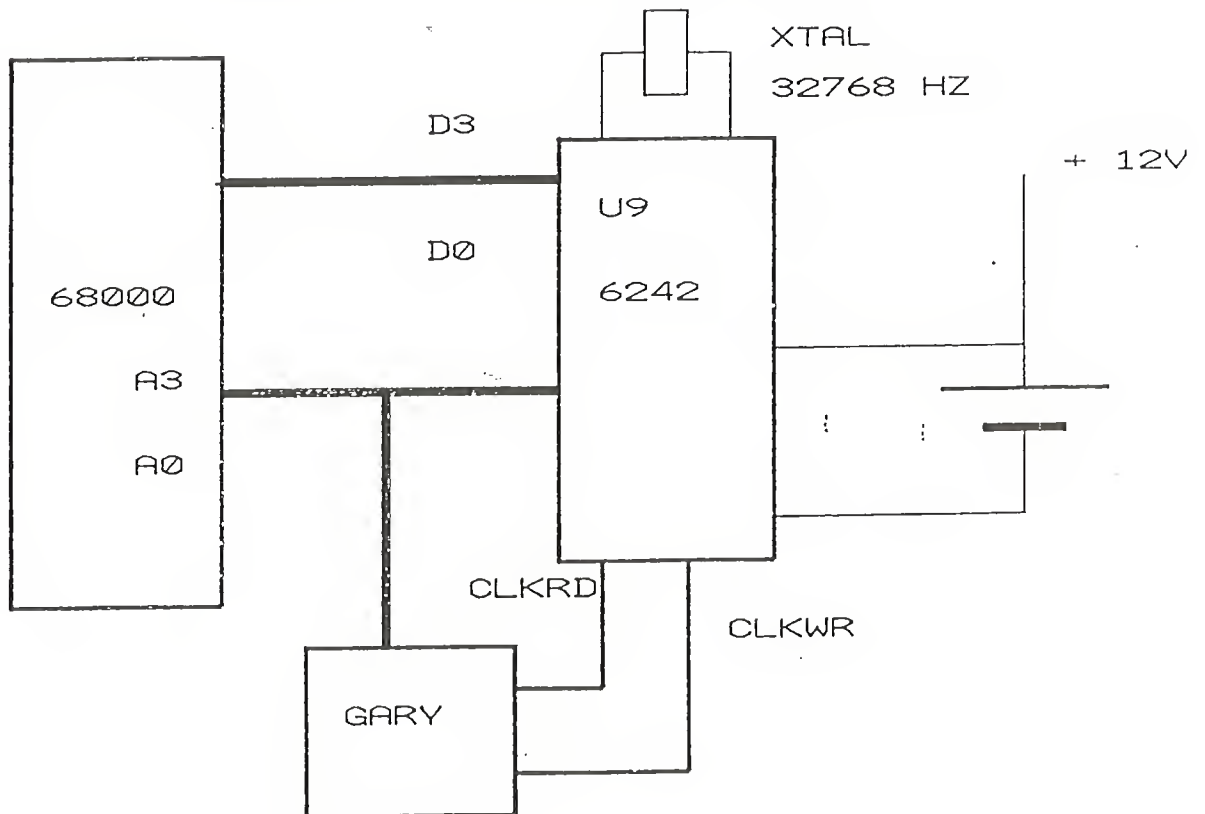
PRINTER INTERFACE

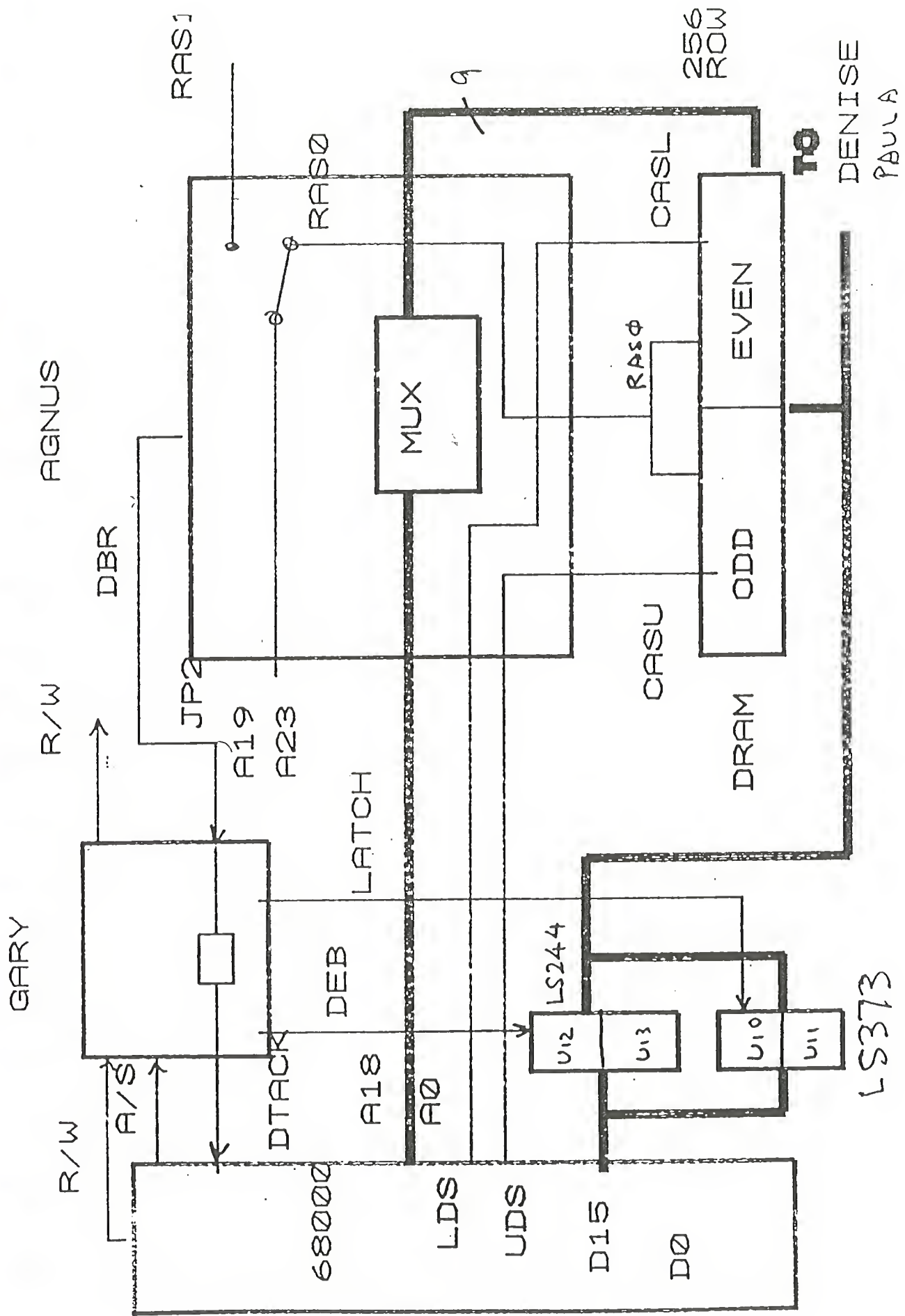


RS232 INTERFACE

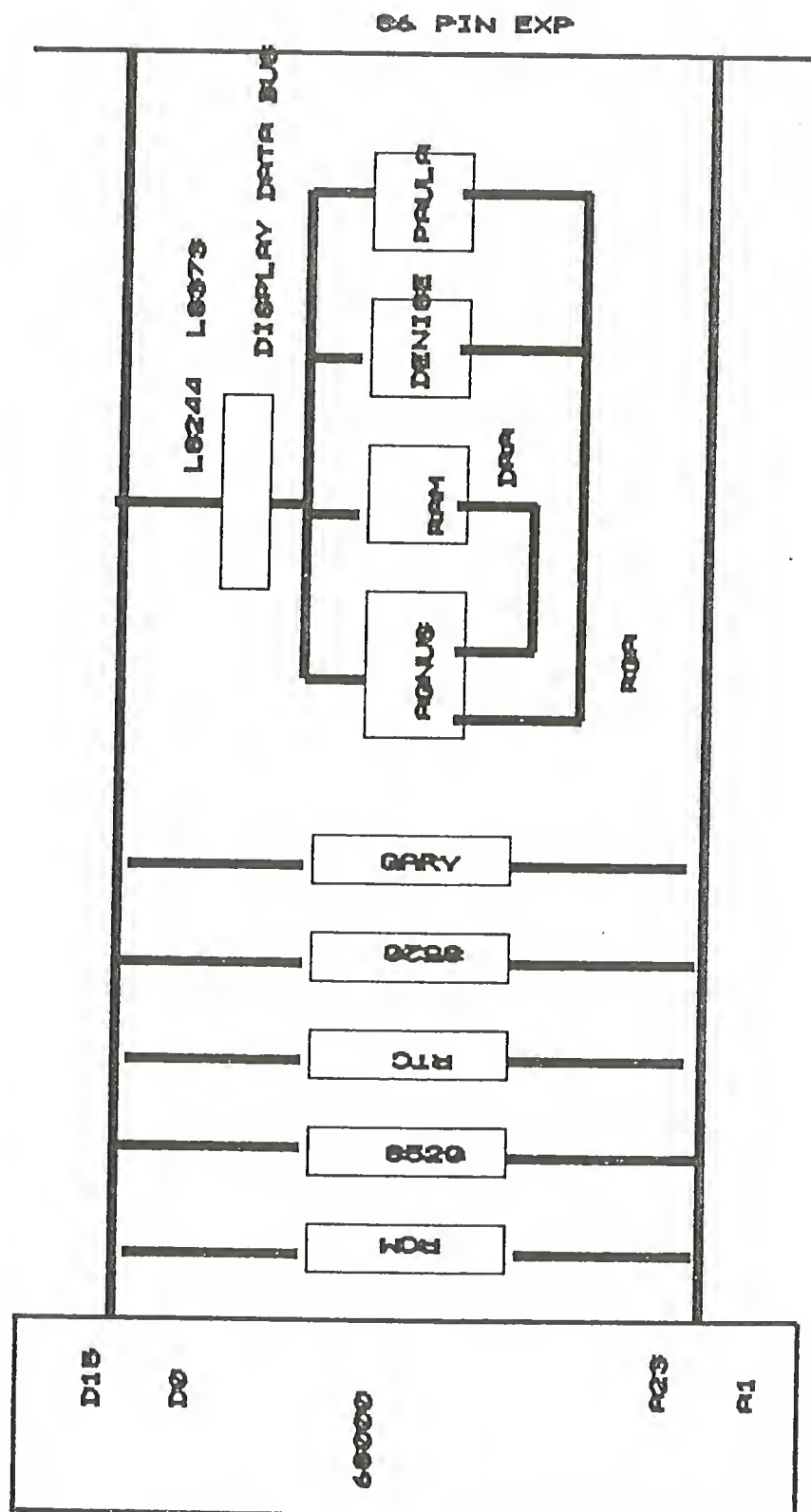


REAL TIME CLOCK

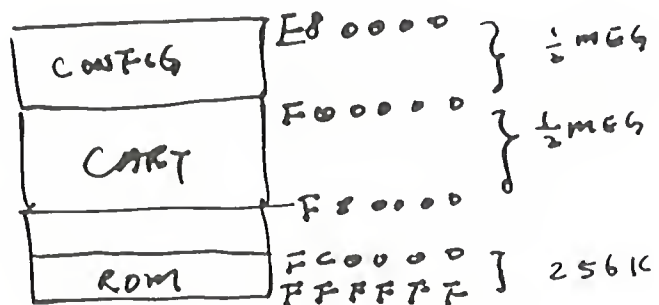
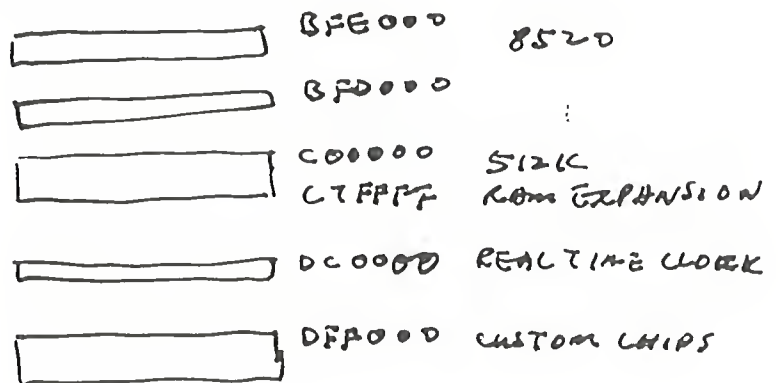
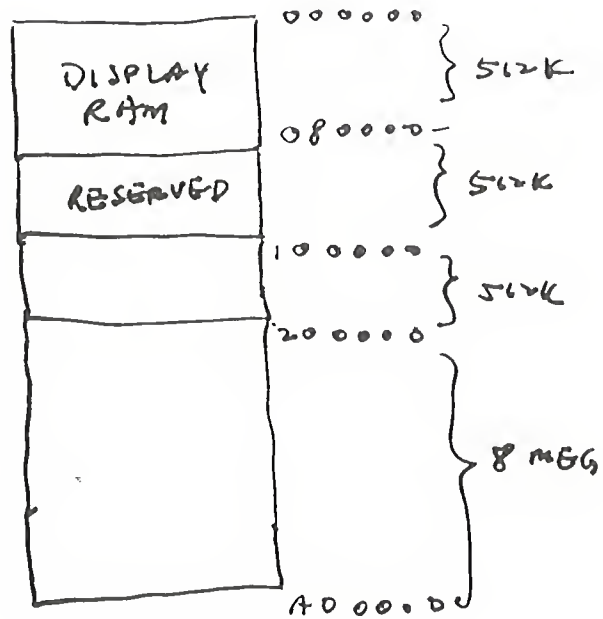




A500 SYSTEM BLOCK DIAGRAM



A500 MEMORY MAP



SOFTWARE APPROACH

- POWER UP DIAGNOSTIC
- ROM BASED DIAGNOSTIC
- DISK BASED DIAGNOSTIC

HARDWARE APPROACH

- REQUIRE TROUBLESHOOTING TOOLS
- DMM DIGITAL MULTIMETER
- LOGIC PROBE (GOOD FOR LOW FREQUENCY PULSES)
- OSCILLOSCOPE
- LOGIC PULSER - GENERATE PULSES OF OPP. LOGIC LEVEL
- SIGNATURE ANALYSER (HP)
16 - OR 24 BIT TEST CODE
SAMPLE THE DATA AT DIFF. PLACES ON A GOOD CIRC. BOARD
- STEADY STATE WAVE FORM COMPARISON
- IN - CIRCUIT TESTING
- NO - OP ANALYSIS
- IN - CIRCUIT EMULATOR

OTHERS

COMMON SENSES; LOOK, SMELL, FEEL

HEAT AND COOL ; TO DETECT INTERMITTENT FAILURE

PIGGY - BACKING; TO DETECT BROKEN BOND INSIDE A CHIP

REPLACING CHIPS ONE AT A TIME;

EFFICIENT FOR SOCKETED CHIPS

MAKES SENSE FOR INEXPENSIVE TTL

EXPERIENCE - FAULT CHART; VERY EFFECTIVE FOR

COMMON FAULTS

FAULTS

CAUSES

GREEN SCREEN

FAT AGNUS SOCKET MEMORY

NO POWER

POWER SUPPLY

CAN'T WRITE TO DISK

DISK DRIVE

PRINTER WON'T WORK

8520, EMI FILTER

WILL NOT LOAD WORKBENCH

8520, DISK DRIVE

2ND J/STICK PORT WON'T WORK

74LS 153

MOUSE WON'T WORK IN ONE DIR.

MOUSE

YELLOW SCREEN

MEMORY FAULT

NO LED

OSC XTAL

HALFWAY LOADING S/WARE

EXP. RAM CART.

WHITE SCREEN

FAT AGNUS

DISK DRIVE READ/WRITE ERROR

CABLE POOR CONTACT

BLACK SCREEN

XTAL

POWER UP DIAGNOSTICS

SEQ	TEST	SCREEN	POSSIBLE CAUSES
1	1/3 SEC. DELAY		
2	JUMP TO ROM CART IF PRESENT (F00000)		
3	DISABLE AND CLR ALL DMA,INT.		
4	CLEAR SCREEN	BLACK	
5	TEST HARDWARE ROM CHECKSUM RAM TEST CUSTOM REQ. UNDEFINED FAILURE	DARK GREY - RED - GREEN - BLUE - YELLOW	ROM U6 RAM, AGNUS, GARY AGNUS, DENISE AND PAULA
6	TEST SOFTWARE	- LIGHT GREY	
7	SET UP DMA & INTERRUPT		
8	START DEFAULT TASK		

KEYBOARD POWER UP SELF TEST

ERROR-CODE – CAPLOCK LED

1 FLASH – ROM CHECKSUM FAILURE

2 FLASH – RAM FAILURE

3 FLASH – CLOCK FAILURE

SYSTEM DIAGNOSTIC

TEST

CAUSE

KEYBOARD MATRIX TEST

KEYBOARD, KB CPU
8520 U7, PAULA

BIT PLANE IMAGES

8371 AGNUS, DENISE,
RAM

MOUSE

MOUSE, U15 74LS157,
DENISE, U7 8520,
PAULA

ANIMATION

AGNUS

R T C

GARY, 6242, XTAL
32768, BATTERY

AUDIO

PAULA, LF347 / TL084

LED ON / OFF

U7 8520, U38, Q301
2 N 3906

SPRITES

AGNUS, DENISE

CHIP RAM

{ RAM , AGNUS, GARY
LS273

FAST RAM

{ F244

DISK

DISK DRIVE, CABLE
PAULA, 8520 GARY

PRODUCT: A588

No : 8988-883

Page : 1 of 2

Subject: To convert A1000 diagnostic board for A500

- 1 Remove all LEDs on U23 and replace it with an IC socket.
- 2 Remove resistor pack on U22 and replace it with an IC socket
- 3 Connect pin 9 of U23 to pin 12 of J8
- 4 Cut trace under pin 12 of J8
- 5 Connect pin 10 of U23 to pin 11 of J8
- 6 Cut trace under pin 11 of J8
- 7 Connect pin 11 of U23 to pin 12 of U12
- 8 Connect pin 12 of U23 to +5V
- 9 Connect pin 14 of U23 to pin 3 of RN5
- 10 connect 1K resistor from pin 15 of U23 to GND
- 11 connect 1K resistor from pin 16 of U23 to GND
- 12 connect pin 15 of U23 to pin 18 of U26
- 13 connect pin 16 of U23 to pin 4 of U26
- 14 cut trace connecting pin 16 of J8 to GND
- 15 connect pin 16 of J8 to pin 13 of U26
- 16 cut trace connecting pin 23 of J8
- 17 cut trace connecting to pin 25 of J8
- 18 connect pin 9 of U22 to top of SW1 (the one not grounded)
- 19 connect pin 17 of J6 to pin 5 of U25
- 20 connect pin 13 of U12 to pin 19 of U25
- 21 connect pin 2 of RN4 to +5V
- 22 cut trace connecting pin 3 of U8 to pin 25 of J8
- 23 remove resistor R15
- 24 remove jumper under resistor R15

PRODUCT: A588

No : 8988-883

Page : 2 of 2

Test code LED connection

U22 pin

3	D7
5	D6
2	D5
6	D4
1	D3
7	D2
4	D1
8	D0

Keyboard connector

KB	U23	cd	
pin		pin	
9		1	data
10		2	clock
11		3	reset
12		4	+ 5V
13		5	
14		6	key
15		7	GND
16		8	status

connector function

J6	SERIAL
J7	EXTERNAL DRIVE
J8	PRINTER
J11	J/S 2
J12	J/S 1

connector pin assignment

26	14
13	1
{ solder side }		

A500 ROM BASED DIAGNOSTIC

- Test 1. Check ability to read last ROM location
This is a general test of processor and 86 pin connector
- Test 2. Set serial port as input, test busy pout
- Test 3. DRDY and ACK test
- Test 4. Check the CBM Serial Bus
- Test 5. Check RTS-CTS bit set loop
- Test 6. Check RTS-CTS bit clear loop
- Test 7. Check DTR-DSR bit set loop
- Test 8. Check DTR-DSR bit clear loop
- Test 9. Roll a zero through the parallel port
- Test a. Roll a one through the parallel port
- Test b. Write/Read a "?" character via the serial connection
- Test c. Write/Read an "E" character via the serial connection
- Test d. Write/Read a "J" character via the serial connection
- Test e. Write/Read a "string" char. via the serial connection
- Test f. Keyboard communication test
- Test 10 "SEL" line set as input, reset, except "CD" to be set
- Test 11 "SEL" line set as input, toggle and check "CD"
- Test 20 Check parallel port reset line
- Test 21 Check disk port reset line
- Test 22 Check serial port reset line
- Test 23 Check parallel port reset line can be set

Test 24 Check disk port reset line can be set
Test 25 Check serial port reset line can be set
Test 26 Check fire lines as output, check if set
Test 27 Check fire lines as output, check if cleared
Test 28 Check fire 1 lines as output
Test 29 Check fire 0 lines as input
Test 2a Check fire 1 lines as input
Test 2b Check fire 0 lines as input
Test 2c Check fire 1 lines as input
Test 2d Check fire 0 lines as input
Test 30 Verify keyboard +5 volts is o.k.
Test 31 Verify serial port +5 volts is o.k.
Test 32 Verify j/stick [1] +5 volts is o.k.
Test 33 Verify j/stick [0] +5 volts is o.k.
Test 34 Verify d/drive +5 volts is o.k.
Test 35 Check keyboard ground keyboard connector
Test 36 Check internal Disk ground Internal disk connector
Test 37 Check external disk ground external disk connector
Test 38 Check serial port ground number 2 serial connector
Test 39 Check serial port ground number 1 serial connector
Test 3a Check joystick [1] ground
Test 3b Check joystick [0] ground
Test 47 Table drive joystick position checking
Test 50 Set all pot lines to output (pull down) verify all low
Test 51 Toggle pot [x] port [1], verify line goes hi
Test 52 Toggle pot [y] port [1], verify line goes hi

Test 53 Toggle pot [x] port [0], verify line goes hi
Test 54 Toggle pot [y] port [0], verify line goes hi
Test 55 Set all pot lines to output (pull up) verify all high
Test 56 Toggle pot [x] port [1], verify line goes lo
Test 57 Toggle pot [y] port [1], verify line goes lo
Test 58 Toggle pot [x] port [0], verify line goes lo
Test 59 Toggle pot [y] port [0], verify line goes lo
Test 5a Set up to begin testing the pots as input
Test 5b Pot input load testing on all
Test 5c Pot input load testing on pot x port 1
Test 5d Port input load testing on pot y port 1
Test 5e Port input load testing on pot x port 0
Test 5f Port input load testing on pot y port 0
Test 60 Test external disk control lines
Test 6a Test internal disk control lines and ground line
Test 6b Test light pen function
Test 72 Test disk RESPONSE line
Test 76 Test disk RESPONSE "INDEX" line
Test 77 Try to force a reset test with a "NARROW" pulse
Test 78 Memory bit checking
Test 79 Complimentary bit checking
Test 7a Sliding ZEROS pattern
Test 7b Sliding ONES pattern
Test 7c Address as DATA test
Test 7d Inverted address as DATA test
Test 7e Bytefill test

Test 80 ROM checksum checking

Test 81/87 RAM/ROM memory check

Test 83 Test ROM/RAM strobe

Test 84 Test ROM/RAM address lines

Test 85 Test ROM/RAM pattern

Test 88 WRITE protect on ROM/RAM

Test 89 Check the four Audio channels, and Audio DMA

Test 90 Custom chip register testing, clear ADKCON

Test 91 Check ADKCON set and clear bit loop

Test 92 Custom chip register testing, clear CLXDAT

Test 93 Check DMACOON [R] resistor

Test 94 Check INTREQ resistor

Test 95 Check INTENA resistor

Test 96 Test joystick resistor pattern #1

Test 97 Test joystick resistor pattern #2

Test 98 Test joystick resistor pattern #3

Test 99 Test joystick resistor pattern #4

Test f0 Check Ram Bus bits 8,9,10,11

Test f1 Check Ram Bus bits 12,13,14,15

Test f2 Check Ram Bus bits 0,1,2,3

Test f3 Check Ram Bus bits 4,5,6,7

Test f4 Check Ram Bus bits 8,9,10,11

Test f5 Check Ram Bus bits 12,13,14,15

Test f6 Check Ram Bus bits 0,1,2,3

Test f7 Check Ram Bus bits 4,5,6,7

STEP 5

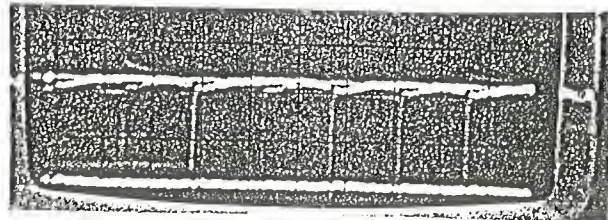
SIGNAL A1-A23

TEST POINT 68000 PIN 29

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

GARY, 68000, ROM, 8520
AGNUS.



STEP 6

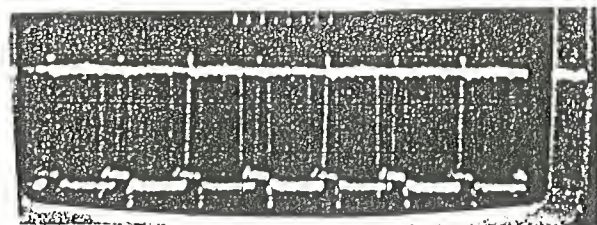
SIGNAL DTACK

TEST POINT 68000 PIN 10

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

GARY



STEP 7

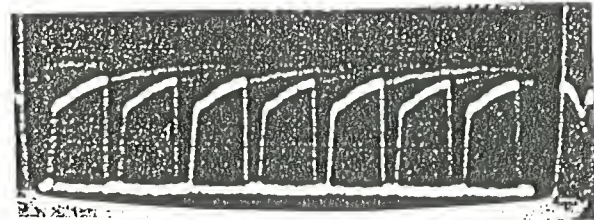
SIGNAL A3, UDS, LDS

TEST POINT 68000 PIN 6, 7, 8

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

68000, ROM, GARY, AGNUS



STEP 8

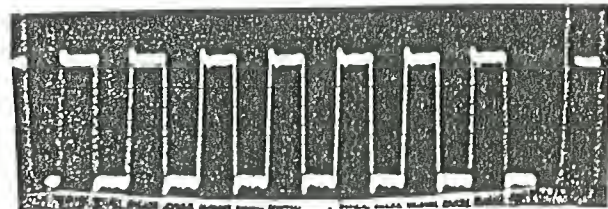
SIGNAL LATCH

TEST POINT GARY PIN 25

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

GARY



WAVEFORM COMPARISON

STEP 1

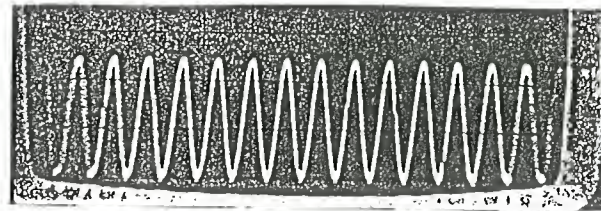
SIGNAL 28 MHz

TEST POINT XTAL X1 PIN 0/P

OSC SETTING .05 μ S/DIV

POSSIBLE CAUSE

VTAL



STEP 2

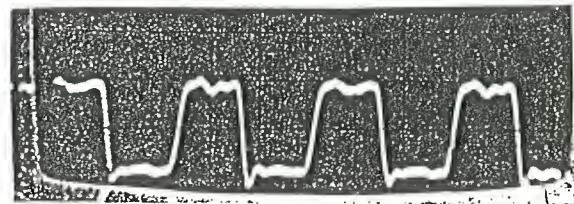
SIGNAL CLK

TEST POINT 68000 PIN 15

OSC SETTING .05 μ S/DIV

POSSIBLE CAUSE

AGNUS



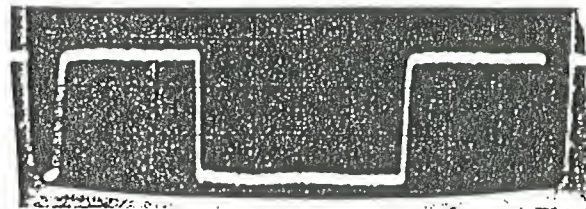
STEP 3

SIGNAL E

TEST POINT 68000 PIN 20

OSC SETTING .2 μ S/DIV

POSSIBLE CAUSE



STEP 4

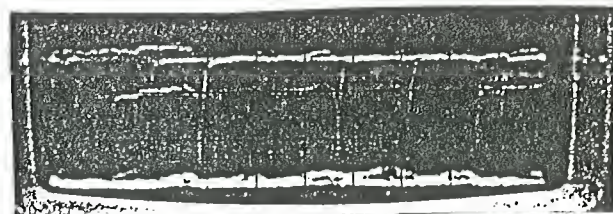
SIGNAL D Φ -DIS

TEST POINT 68000 PIN 5

OSC SETTING .2 μ S/DIV

POSSIBLE CAUSE

68000, ROM, V10, V12, 8520



STEP 9

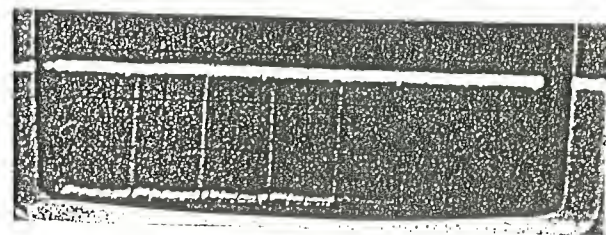
SIGNAL DEB

TEST POINT GARY PIN 4

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

GARY



STEP 10

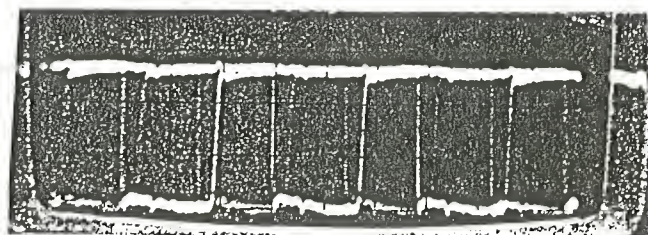
SIGNAL ROMEN

TEST POINT GARY PIN 21

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

GARY



STEP 11

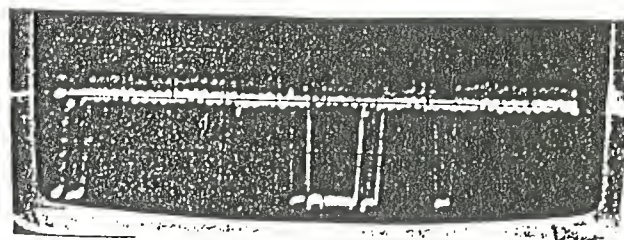
SIGNAL RGAI-RGA8

TEST POINT AGNUS PIN

OSC SETTING .2M S/DIV

POSSIBLE CAUSE

AGNUS



STEP 12

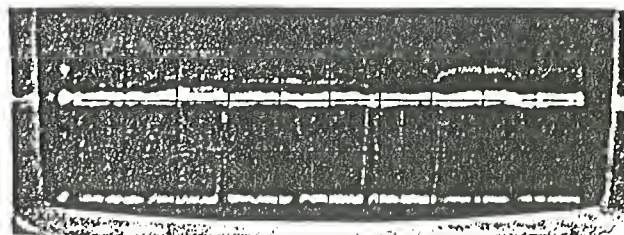
SIGNAL DRAΦ-DRA8

TEST POINT AGNUS PIN

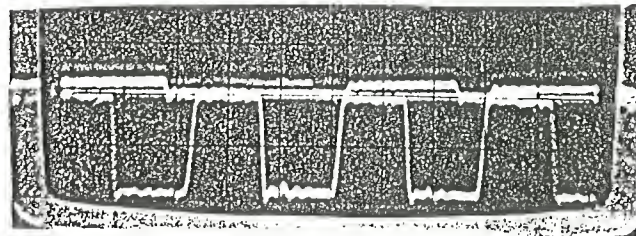
OSC SETTING .2M S/DIV

POSSIBLE CAUSE

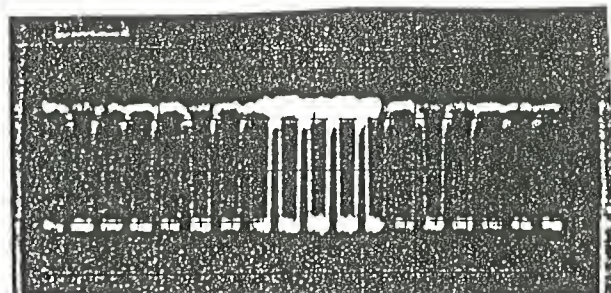
AGNUS



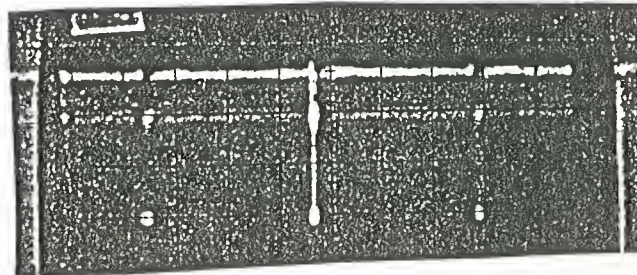
STEP 13
SIGNAL CASL, CASH
TEST POINT AGNUS PIN 54, 55
OSC SETTING .1 S/DIV
POSSIBLE CAUSE
AGNUS



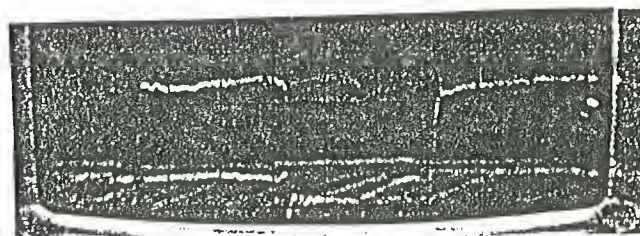
STEP 14
SIGNAL RASΦ
TEST POINT AGNUS PIN 57
OSC SETTING 0.5μ S/DIV
POSSIBLE CAUSE
AGNUS



STEP 15
SIGNAL RAS1
TEST POINT AGNUS PIN 56
OSC SETTING 20μ S/DIV
POSSIBLE CAUSE
AGNUS



STEP 16
SIGNAL DRDΦ-DRD15
TEST POINT 8364 PIN 10
OSC SETTING .2μ S/DIV
POSSIBLE CAUSE
RAM, AGNUS, DENISE, PAULA,
V12, V10, V13, V11
F244 LS373



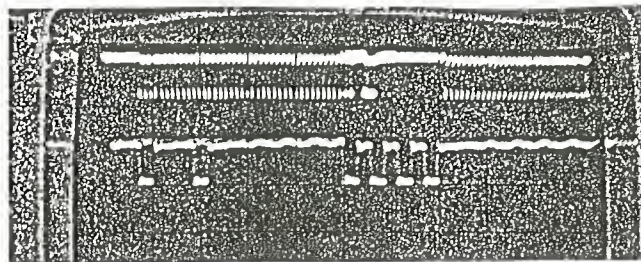
STEP 17

SIGNAL PBR

TEST POINT AGNUS PIN 20

OSC SETTING 10ns 1ms S/DIV

POSSIBLE CAUSE
AGNUS



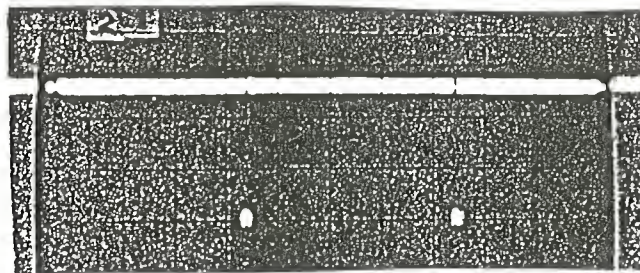
STEP 19

SIGNAL IPLD.1

TEST POINT 8364 PIN 13,14

OSC SETTING 5μ S/DIV

POSSIBLE CAUSE
PAULA, 8520, AGNUS



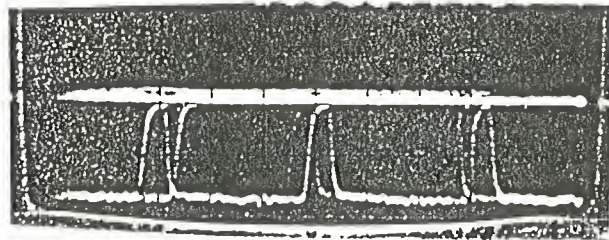
STEP 20

SIGNAL DRAM ADDRESS

TEST POINT RAM PIN 1

OSC SETTING .1μ S/DIV

POSSIBLE CAUSE
DRAM, U34



STEP _____

SIGNAL _____

TEST POINT _____ PIN _____

OSC SETTING _____ S/DIV

POSSIBLE CAUSE

DRAM REFRESH WAVEFORM - CPU REMOVED

STEP _____

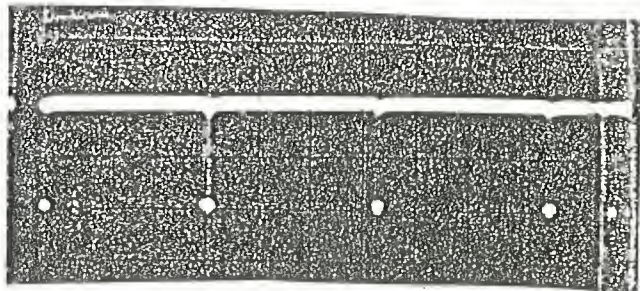
SIGNAL RAS

TEST POINT DRAM PIN 4

OSC SETTING .05M S/DIV

POSSIBLE CAUSE

AGNUS



STEP _____

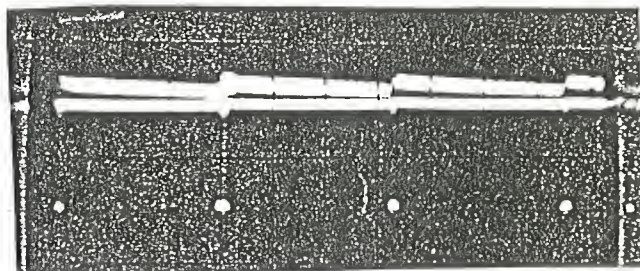
SIGNAL ADDRESS

TEST POINT DRAM PIN 5

OSC SETTING .05M S/DIV

POSSIBLE CAUSE

AGNUS, DRAM, U34



STEP _____

SIGNAL _____

TEST POINT _____ PIN _____

OSC SETTING _____ S/DIV

POSSIBLE CAUSE

STEP _____

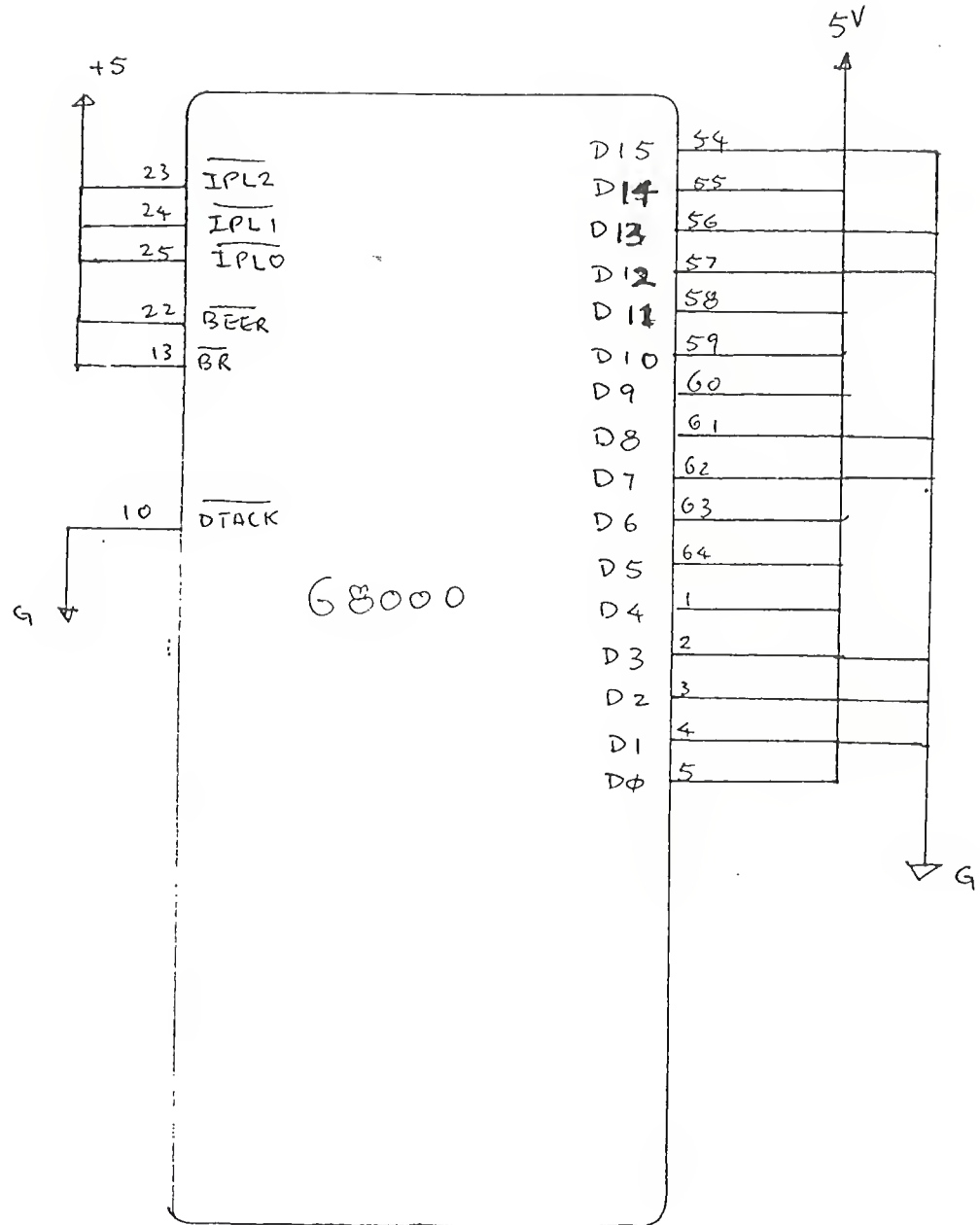
SIGNAL _____

TEST POINT _____ PIN _____

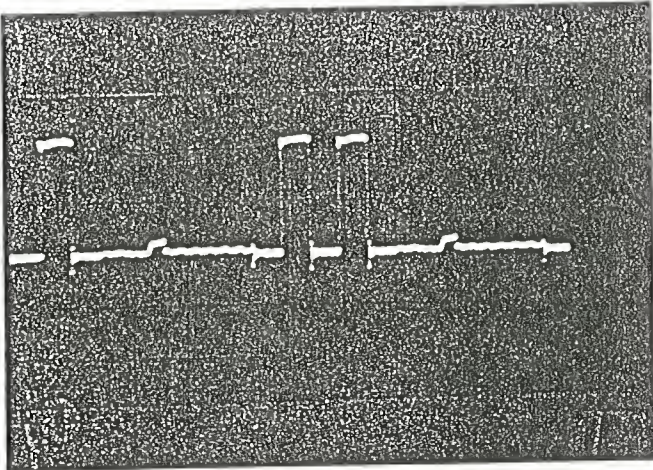
OSC SETTING _____ S/DIV

POSSIBLE CAUSE

NO OPT 68000

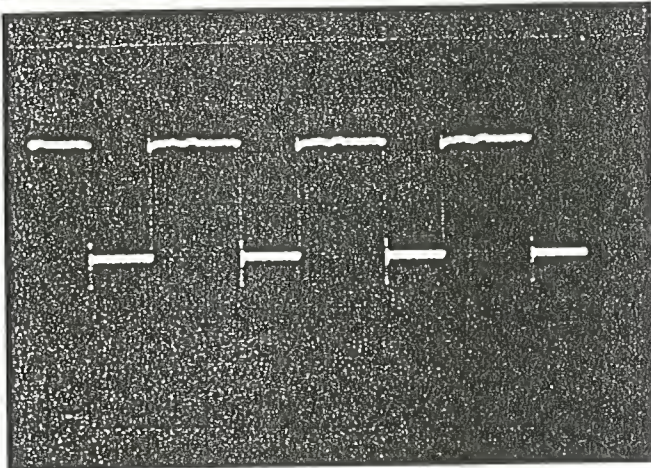


NO - OFF

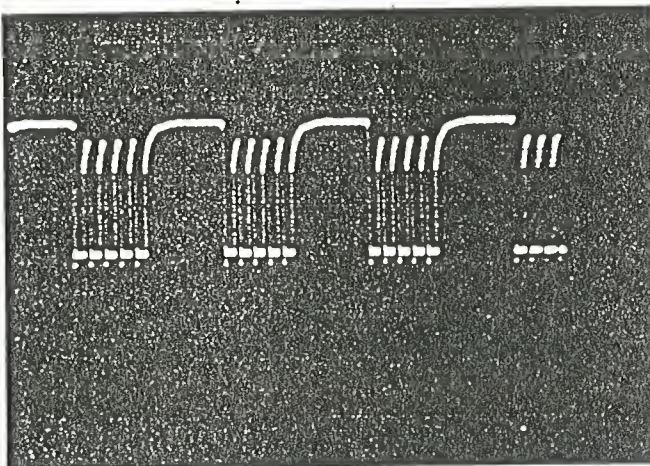


A1, A2
1 μ s

'0' A3, A7, A15
A17, A18, A23
'1'



2 μ s
A4, A5, A6, A9,
A14, A16, A20, A21
A22
A12, A13 2.5V

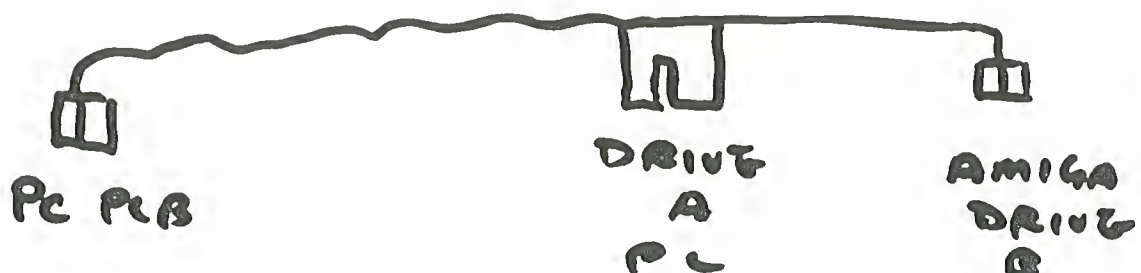
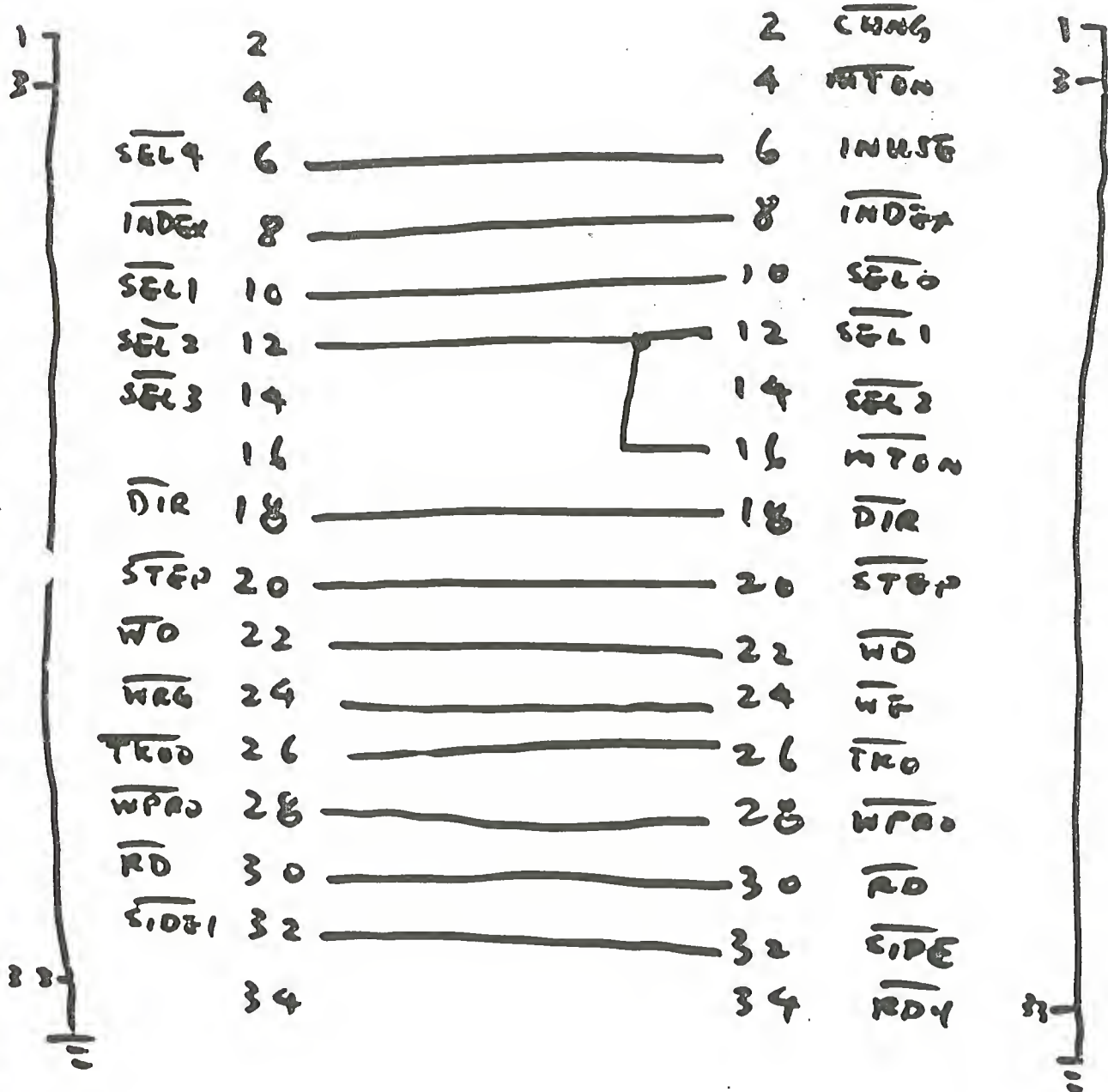


A 2 μ s
A8, UDS, LDS

DISK DRIVE ALIGNMENT ADAPTOR CABLE (AMIGA DRIVE TO PC)

PC

AMIGA DRIVE
B



DRIVE MOTOR SPEED ADJUSTMENT

If the reading from the Speed Test is not within the allowed limits of 295-305, the motor speed must be adjusted. Although the procedure for this adjustment is the same for all drives, the location of the Motor Speed Control Pot will vary. The Internal Drive Mechanism can be identified once the Amiga Top Shield and RF Shield have been removed. The External Drive Mechanism can be identified once the top has been removed from the External Drive.

DRIVE VENDOR IDENTIFICATION

1. NEWTRONICS DRIVE ASSEMBLY - Label on back of the Drive Mechanism ...

```
*****
* D357                                     *
* MITSUMI ELEC. CO., LTD                 *
* MADE IN JAPAN                         *
*****
```

2. PANASONIC DRIVE ASSEMBLY - Label on the top of the drive Mounting Bracket..

```
*****
* MODEL JU-363-03                         *
* MATSUSHITA COMMUNICATION                *
* MADE IN JAPAN                         *
*****
```

3. NEC DRIVE ASSEMBLY - Label on the back of the Drive Mechanism..

```
*****
* FD1035                                 *
* NEC CORPORATION                       *
* MADE IN JAPAN                       *
*****
```

4. CHINON DRIVE ASSEMBLY - Label on the side of the drive Mechanism..

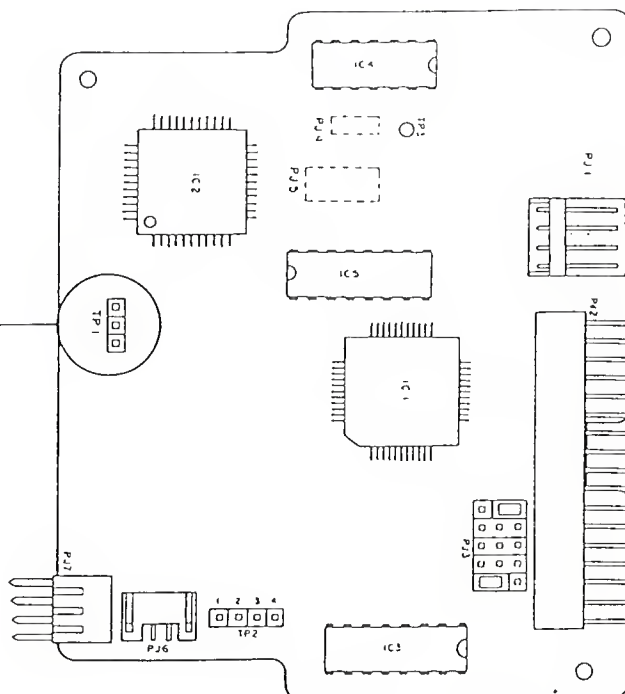
```
*****
* F-354E                                 *
* CHINON IND, INC.                      *
* MADE IN JAPAN                       *
*****
```

The Motor Speed is adjusted by turning the Motor Speed Control POT until the displayed speed reading is equal to (300). the location of the Motor Speed Control POTS are listed below.

- (A) NEWTRONICS - Top Right Hand Side of the Drive Mechanism behind the Plastic Plate. Accessed from the top of the Drive Assembly.
- (B) PANASONIC - Designated as (VR1) on the Drive PCB. Accessed from the bottom of the Drive Assembly.
- (C) NEC - Designated as (VR1) on the Drive PCB. Accessed from the bottom of the Drive Assembly.
- (D) CHINON - Designated as (VR1) on the Drive PCB. Accessed from the bottom of the Drive Assembly.

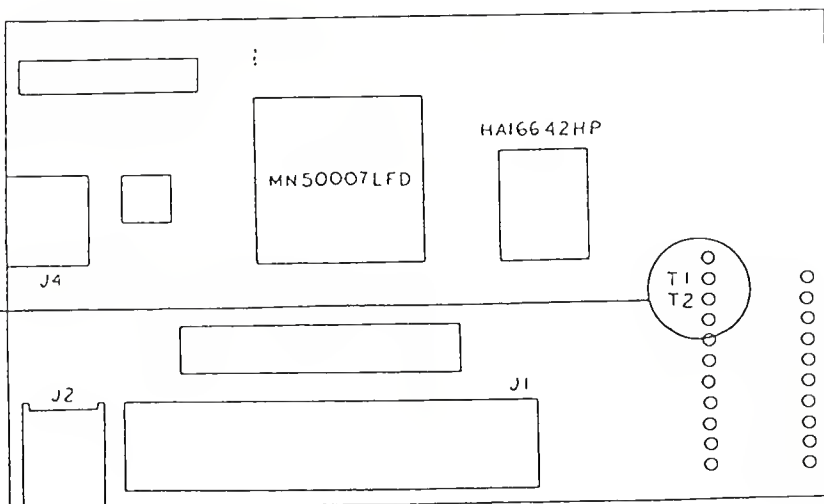
CHINON
(F - 354E)

ALIGNMENT TEST POINTS
USE - TP1, 1ST AND 3RD PINS



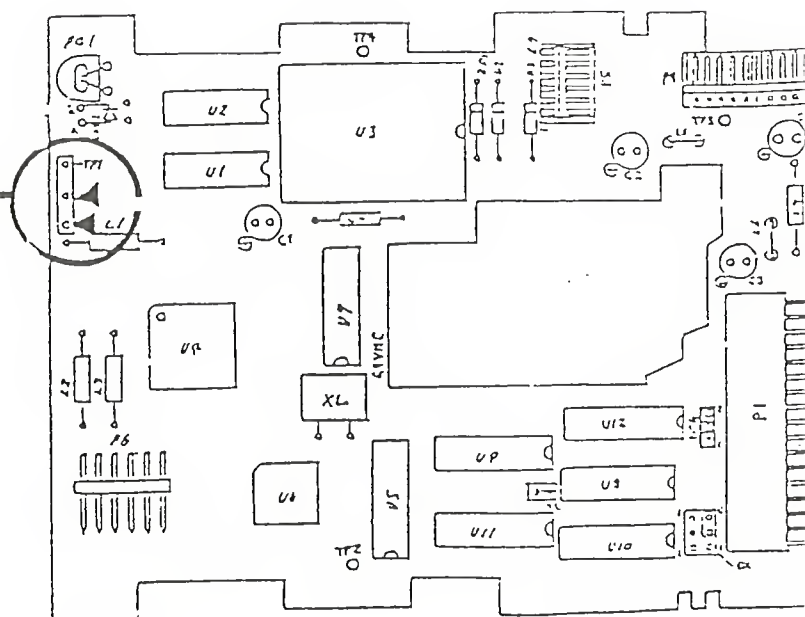
PANASONIC
(MATSUSHITA JU363 - 03)

ALIGNMENT TEST POINTS
USE - T1 AND T2



NEC
(FD1035-008)

ALIGNMENT TEST POINTS
USE - TP1, 2ND AND 3RD LEADS



NEWTRONICS
(MITSUMI D357)

ALIGNMENT TEST POINTS
USE - N AND P

